

Features

High density

- 15K to 350K usable gates
- 256 to 5376 macrocells
- -92 to 520 maximum I/O pins
- -12 Dedicated Inputs including 4 clock pins, 4 global control signal pins and 4 JTAG interface pins for reconfigurability

Embedded Memory

- 40K to 840K bits embedded SRAM
 - 32K to 672K bits of (single port) Cluster memory
- 8K to 168K bits of (dual port) Channel memory
- •High speed 250-MHz in-system operation AnyVolt[™] interface
 - 3.3V, 2.5V and 1.8V V_{CC} versions available
 - 3.3V, 2.5V and 1.8V I/O capability on all versions
- Low Power Operation
 - -0.18-μm 6-layer metal SRAM-based logic process
 - Full-CMOS implementation of product term array
- Standby current as low as 100 µA at 1.8V V_{CC} Simple timing model
 - No penalty for using full 16 product terms / macrocell
- No delay for single product term steering or sharing •Flexible clocking
 - 4 synchronous clocks per device
 - —1 spread-aware PLL drives all 4 clock networks
 - Locally generated Product Term clock
 - Clock polarity control at each register
- •Carry-chain logic for fast and efficient arithmetic operations

CPLDs at FPGA Densities[™]

•Multiple I/O standards supported

-LVCMOS (3.3/3.0/2.5/1.8V), LVTTL, 3.3V PCI, SSTL2 (I-II), SSTL3 (I-II), HSTL (I-IV), and GTL+

•Compatible with NOBL[™], ZBT[™], and QDR[™] SRAMs •Programmable slew rate control on each I/O pin •User-Programmable Bus Hold capability on each I/O pin •Fully PCI compliant (to 66 MHz 64-bit PCI spec rev2.2) •Compact PCI hot swap compatible

•Multiple package/pinout offering across all densities

- -144 to 676 pins in PQFP, BGA and FBGA packages
- Same pinout for 3.3V/2.5V and 1.8V devices
- Simplifies design migration across density
- Self-Boot[™] solution in BGA and FBGA packages In-System Reprogrammable[™] (ISR[™])
 - JTAG-compliant on-board programming
- Design changes don't cause pinout changes •IEEE1149.1 JTAG boundary scan

Development Software

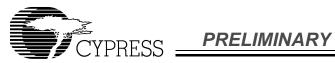
- •Warp[™]
 - IEEE 1076/1164 VHDL or IEEE 1364 Verilog context sensitive editing.
 - Active-HDL FSM graphical finite state machine editor
 - Active-HDL SIM post-synthesis timing simulator
 - Architecture Explorer for detailed design analysis
 - Static Timing Analyzer for critical path analysis
 - Available on Windows 95, 98 & NT for \$99
 - Supports all Cypress Programmable Logic Products

	Typical		Cluster memory	Channel memory			y I _{CC} ^[2] 25°C		
Device	Gates ^[1]	Macrocells	(Kbits)	(Kbits)	I/O Pins	(MHz)	(ns)	3.3/2.5V	1.8V
39K15	8K–24K	256	32	8	134	256	6.5	10 mA	100 μA
39K30	16K–48K	512	64	16	176	238	7.0	10 mA	200 µA
39K50	23K–72K	768	96	24	218	238	7.0	10 mA	300 μA
39K100	46K–144K	1536	192	48	302	222	7.5	10 mA	600 μA
39K165	77K–241K	2560	320	80	386	181	8.5	10 mA	1250 μA
39K200	92K–288K	3072	384	96	428	181	8.5	10 mA	1250 μA
39K250	115K–361K	3840	480	120	470	167	8.5	10 mA	1500 μA
39K350	161K–505K	5376	672	168	520	154	9.0	10 mA	2100 μA

Delta39K[™] ISR CPLD Family Members

Upper limit of typical gates is calculated by assuming only 10% of the channel memory is used. Standby $I_{\rm CC}$ values are with PLL not utilized, no output load and stable inputs 1.

Note:



Delta39K Speed Bins^[3]

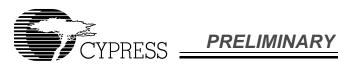
Device	250	222	200	181	167	154	125	83
39K15	Х						Х	Х
39K30		Х					Х	Х
39K50		Х					Х	Х
39K100			Х				Х	Х
39K165				Х			Х	Х
39K200				Х			Х	Х
39K250					Х		Х	Х
39K350						Х	Х	Х

Device Package Offering and I/O Count Including Dedicated Clock and Control Inputs

							Self-Boot	Solution ^[4]	
Device	208-EQFP 28X28 mm 0.5-mm pitch	144-FBGA 13x13 mm 1.0-mm pitch	256-FBGA 17x17 mm 1.0-mm pitch	484-FBGA 23x23 mm 1.0-mm pitch	676-FBGA 27x27 mm 1.0-mm pitch	256-FBGA 17x17 mm 1.0-mm pitch	388-BGA 35x35 mm 1.27-mm pitch	484-FBGA 23x23 mm 1.0-mm pitch	676-FBGA 27x27 mm 1.0-mm pitch
39K15	134	92	134			134			
39K30	136	92	176			176			
39K50	136		180				218	218	
39K100	136		180	302			294		302
39K165	136			356			294		386
39K200	136			368			294		428
39K250	136				470		294		470
39K350	136				520		294		520

Notes:

Speed bins shown here are for Commercial operating range. Please refer to Delta39K Ordering Information on page 41 for Industrial range speed bins. Self-Boot Solution integrates the boot PROM (Flash Memory) with Delta39K die inside the same package. 3. 4.



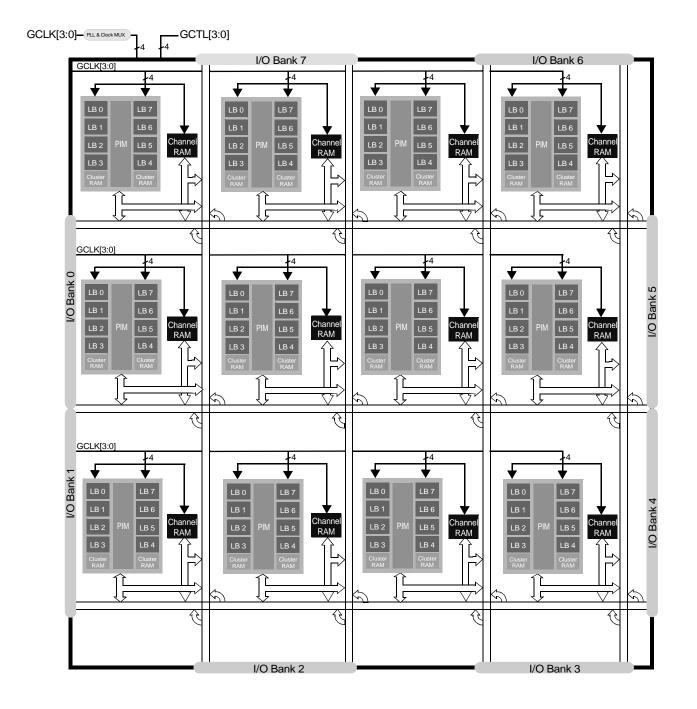


Figure 1. Delta39K100 Block Diagram (3 Rows x 4 Columns) with I/O Bank Structure



General Description

The Delta39K family, based on a 0.18 μ m, 6-layer metal CMOS logic process, offers a wide range of high-density solutions at unparalleled system performance. The Delta39K family is designed to combine the high speed, predictable timing, and ease of use of CPLDs with the high densities and low power of FPGAs. With devices ranging from 15,000 to 350,000 usable gates, the family features devices ten times the size of previously available CPLDs. Even at these large densities, the Delta39K family is fast enough to implement a fully synthesizable 64-bit, 66-MHz PCI core.

The architecture is based on Logic Block Clusters (LBC) that are connected by Horizontal and Vertical (H&V) routing channels. Each LBC features eight individual Logic Blocks (LB) and two cluster memory blocks. Adjacent to each LBC is a channel memory block, which can be accessed directly from the I/O pins. Both types of memory blocks are highly configurable and can be cascaded in width and depth. See *Figure 1* for a block diagram of the Delta39K architecture.

All the members of the Delta39K family have Cypress's highly regarded In-System Reprogrammability (ISR) feature, which simplifies both design and manufacturing flows, thereby reducing costs. The ISR feature provides the ability to reconfigure the devices without having design changes cause pinout or timing changes in most cases. The Cypress ISR function is implemented through a JTAG-compliant serial interface. Data is shifted in and out through the TDI and TDO pins respectively. Superior routability, simple timing, and the ISR allows users to change existing logic designs while simultaneously fixing pinout assignments and maintaining system performance.

The entire family features JTAG for ISR and boundary scan, and is compatible with the PCI Local Bus specification, meeting the electrical and timing requirements. The Delta39K family also features user programmable bus-hold and slew rate control capabilities on each I/O pin.

AnyVolt Interface

All Delta39KV devices feature an on-chip regulator, which accepts 3.3V or 2.5V on the V_{CC} supply pins and steps it down to 1.8V internally, the voltage level at which the core operates.

The Delta39KZ devices accept 1.8V on the V_{CC} supply pins directly. With Delta39K's AnyVolt technology, the I/O pins can be connected to either 1.8V, 2.5V, or 3.3V. All Delta39K devices are 3.3V tolerant regardless of V_{CCIO} or V_{CC} settings.

Device	V _{cc}	V _{CCIO}
39KV	3.3V or 2.5V	3.3V or 2.5V or 1.8V or 1.5V ^[5]
39KZ	1.8V	3.3V or 2.5V or 1.8V or 1.5V ^[5]

Global Routing Description

The routing architecture of the Delta39K is made up of horizontal and vertical (H&V) routing channels. These routing channels allow signals from each of the Delta39K architectural components to communicate with one another. In addition to the horizontal and vertical routing channels that interconnect the I/O banks, channel memory blocks, and logic block clusters, each LBC contains a Programmable Interconnect Matrix (PIM[™]), which is used to route signals among the logic blocks and the cluster memory blocks.

Figure 2 is a block diagram of the routing channels that interface within the Delta39K architecture. The LBC is exactly the same for every member of the Delta39K CPLD family.

Logic Block Cluster (LBC)

The Delta39K architecture consists of several logic block clusters, each of which have 8 Logic Blocks (LB) and 2 cluster memory blocks connected via a Programmable Interconnect Matrix (PIM) as shown in *Figure* 3. Each cluster memory block consists of 8-Kbit single-port RAM, which is configurable as synchronous or asynchronous. The cluster memory blocks can be cascaded with other cluster memory blocks within the same LBC as well as other LBCs to implement larger memory functions. If a cluster memory block is not specifically utilized by the designer, Cypress's *Warp* software can automatically use it to implement large blocks of logic.

All LBCs interface with each other via horizontal and vertical routing channels.

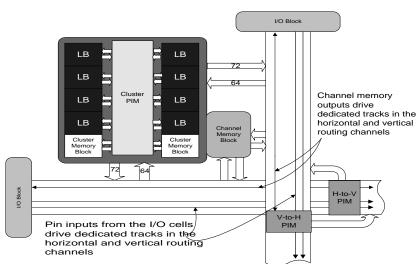
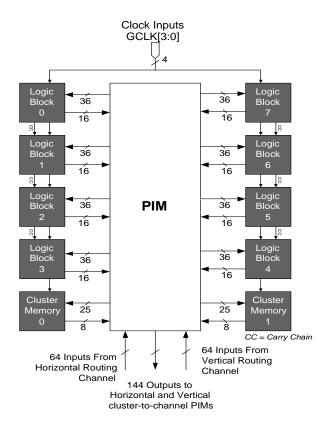


Figure 2. Delta39K Routing Interface

Note: 5. For HSTL only. Document #: 38-03039 Rev. **



PRELIMINARY

Figure 3. Delta39K Logic Block Cluster Diagram

Logic Block (LB)

The logic block is the basic building block of the Delta39K architecture. It consists of a product term array, an intelligent product-term allocator, and 16 macrocells.

Product Term Array

Each logic block features a 72 x 83 programmable product term array. This array accepts 36 inputs from the PIM. These inputs originate from device pins and macrocell feedbacks as well as cluster memory and channel memory feedbacks. Active LOW and active HIGH versions of each of these inputs are generated to create the full 72-input field. The 83 product terms in the array can be created from any of the 72 inputs.

Of the 83 product terms, 80 are for general-purpose use for the 16 macrocells in the logic block. Two of the remaining three product terms in the logic block are used as asynchronous set and asynchronous reset product terms. The final product term is the Product Term clock (PTCLK) and is shared by all 16 macrocells within a logic block.

Product Term Allocator

Through the product term allocator, *Warp* software automatically distributes the 80 product terms as needed among the 16 macrocells in the logic block. The product term allocator pro-

vides two important capabilities without affecting performance: product term steering and product term sharing.

Product Term Steering

Product term steering is the process of assigning product terms to macrocells as needed. For example, if one macrocell requires ten product terms while another needs just three, the product term allocator will "steer" ten product terms to one macrocell and three to the other. On Delta39K devices, product terms are steered on an individual basis. Any number between 1 and 16 product terms can be steered to any macrocell.

Product Term Sharing

Product term sharing is the process of using the same product term among multiple macrocells. For example, if more than one function has one or more product terms in its equation that are common to other functions, those product terms are only programmed once. The Delta39K product term allocator allows sharing across groups of four macrocells in a variable fashion. The software automatically takes advantage of this capability so that the user does not have to intervene.

Note that neither product term sharing nor product term steering have any effect on the speed of the product. All steering and sharing configurations have been incorporated in the timing specifications for the Delta39K devices.



Macrocell

Within each logic block there are 16 macrocells. Each macrocell accepts a sum of up to 16 product terms from the product term array. The sum of these 16 product terms can be output in either registered or combinatorial mode. *Figure 4* displays the block diagram of the macrocell. The register can be asynchronously preset or asynchronously reset at the macrocell level with the separate preset and reset product terms. Each of these product terms features programmable polarity. This allows the registers to be preset or reset based on an AND expression or an OR expression.

An XOR gate in the Delta39K macrocell allows for many different types of equations to be realized. It can be used as a polarity mux to implement the true or complement form of an equation in the product term array or as a toggle to turn the D flip-flop into a T flip-flop. The carry-chain input mux allows additional flexibility for the implementation of different types of logic. The macrocell can utilize the carry chain logic to implement adders, subtractors, magnitude comparators, parity tree, or even generic XOR logic. The output of the macrocell is either registered or combinatorial.

Carry Chain Logic

The Delta39K macrocell features carry chain logic which is used for fast and efficient implementation of arithmetic operations. The carry logic connects macrocells in up to 4 logic blocks for a total of 64 macrocells. Effective data path operations are implemented through the use of carry-in arithmetic, which drives through the circuit quickly. *Figure 4* shows that the carry chain logic within the macrocell consists of two product terms (CPT0 and CPT1) from the PTA and an input carry-in for carry logic. The inputs to the carry chain mux are connected directly to the product terms in the PTA. The output of the carry chain mux generates the carry-out for the next macrocell in the logic block as well as the local carry input that is connected to an input of the XOR input mux. Carry-in and a configuration bit are inputs to an AND gate. This AND gate provides a method of segmenting the carry chain in any macrocell in the logic block.

Macrocell Clocks

Clocking of the register is highly flexible. Four global synchronous clocks (GCLK[3:0]) and a Product Term clock (PTCLK) are available at each macrocell register. Furthermore, a clock polarity mux within each macrocell allows the register to be clocked on the rising or the falling edge (see macrocell diagram in *Figure 4*).

PRESET/RESET Configurations

The macrocell register can be asynchronously preset and reset using the PRESET and RESET mux. Both signals are active high and can be controlled by either of two Preset/Reset product terms (PRC[1:0] in *Figure 4*) or GND. In situations where the PRESET and RESET are active at the same time, RESET takes priority over PRESET.

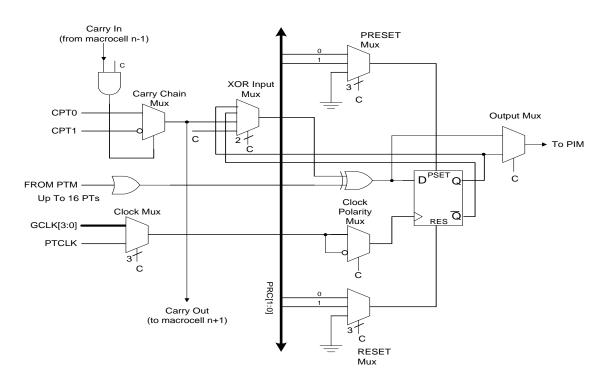


Figure 4. Delta39K Macrocell



Embedded Memory

Each member of the Delta39K family contains two types of embedded memory blocks. The channel memory block is placed at the intersection of horizontal and vertical routing channels. Each channel memory block is 4096 bits in size and can be configured as asynchronous or synchronous Dual-Port RAM, Single-Port RAM, Read-Only memory (ROM), or synchronous FIFO memory. The memory organization is configurable as 4Kx1, 2Kx2, 1Kx4 and 512x8. The second type of memory block is located within each LBC and is referred to as a cluster memory block. Each LBC contains two cluster memory blocks that are 8192-bits in size. Similar to the channel memory blocks, the cluster memory blocks can be configured as 8Kx1, 4Kx2, 2Kx4 and 1Kx8 asynchronous or synchronous Single-Port RAM or ROM.

Cluster Memory

Each logic block cluster of the Delta39K contains two 8192-bit cluster memory blocks. *Figure 5* is a block diagram of the cluster memory block and the interface of the cluster memory block to the cluster PIM.

The output of the cluster memory block can be optionally registered to perform synchronous pipelining or to register asynchronous read and write operations. The output registers contain an asynchronous RESET which can be used in any type of sequential logic circuits (e.g., state machines).

There are four global clocks (GCLK[3:0]) and one local clock available for the input and the output registers. The local clock for the input registers is independent of the one used for the output registers. The local clock is generated in the user-design in a macrocell or comes from an I/O pin.

Cluster Memory Initialization

The cluster memory powers up in an undefined state, but is set to a user-defined known state during configuration. To facilitate the use of look-up-table (LUT) logic and ROM applications, the cluster memory blocks can be initialized with a given set of data when the device is configured at power up. For LUT and ROM applications, the user cannot write to memory blocks.

Channel Memory

The Delta39K architecture includes an embedded memory block at each crossing point of horizontal and vertical routing channels. The channel memory is a 4096-bit embedded memory block that can be configured as asynchronous or synchronous Single-Port RAM, Dual-Port RAM, ROM, or synchronous FIFO memory.

Data, address, and control inputs to the channel memory are driven from horizontal and vertical routing channels. All data and FIFO logic outputs drive dedicated tracks in the horizontal and vertical routing channels. The clocks for the channel memory block are selected from four global clocks and pin inputs from the horizontal and vertical channels. The clock muxes also include a polarity mux for each clock so that the user can choose an inverted clock.

Dual-Port (Channel Memory) Configuration

Each port has distinct address inputs, as well as separate data and control inputs that can be accessed simultaneously. The inputs to the Dual-Port memory are driven from the horizontal and vertical routing channels. The data outputs drive dedicated tracks in the routing channels. The interface to the routing is such that Port A of the Dual-Port interfaces primarily with the horizontal routing channel and Port B interfaces primarily with the vertical routing channel.

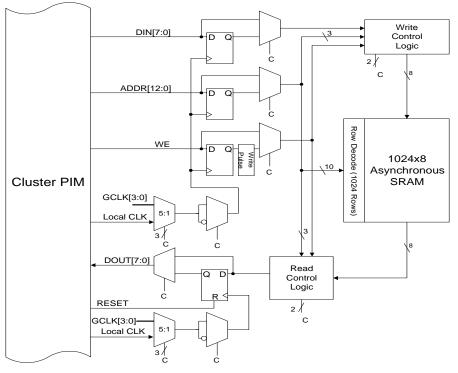
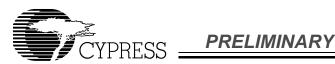


Figure 5. Block Diagram of Cluster Memory Block



The clocks for each port of the Dual-Port configuration are selected from four global clocks and two local clocks. One local clock is sourced from the horizontal channel and the other from the vertical channel. The data outputs of the dual-port memory can also be registered. Clocks for the output registers are also selected from four global clocks and two local clocks. One clock polarity mux per port allows the use of true or complement polarity for input and output clocking purposes.

Arbitration

The Dual-Port configuration of the Channel Memory Block provides arbitration when both ports access the same address at the same time. Depending on the memory operation being attempted, one port always gets priority. See *Table 1* for details on which port gets priority for read and write operations. An active-LOW 'Address Match' signal is generated when an address collision occurs.

Table 1. Arbitration Result: Address Match Signal Becomes Active

Port A	Port B	Result of Arbitration	Comment
Read	Read	No arbitration required	Both ports read at the same time
Write	Read	Port A gets priority	If Port B requests first then it will read the cur- rent data. The output will then change to the newly written data by Port A
Read	Write	Port B gets priority	If Port A requests first then it will read the cur- rent data. The output will then change to the newly written data by Port B
Write	Write	Port A gets priority	Port B is blocked until Port A is finished writing

FIFO (Channel Memory) Configuration

The channel memory blocks are also configurable as synchronous FIFO RAM. In the FIFO mode of operation, the channel memory block supports all normal FIFO operations without the use of any general-purpose logic resources in the device.

The FIFO block contains all of the necessary FIFO flag logic, including the read and write address pointers. The FIFO flags include an empty/full flag (\overline{EF}), half-full flag (\overline{HF}), and programmable almost-empty/full (PAEF) flag output. The FIFO configuration has the ability to perform simultaneous read and write operations using two separate clocks. These clocks may be tied together for a single operation or may run independently for asynchronous Read/Write (w.r.t. each other) applications. The data and control inputs to the FIFO block are driven from the horizontal or vertical routing channels. The data and flag outputs are driven onto dedicated routing tracks in both the horizontal and vertical routing channels. This allows the FIFO blocks to be expanded by using multiple FIFO blocks on the same horizontal or vertical routing channel without any speed penalty.

In FIFO mode, the write and read ports are controlled by separate clock and enable signals. The clocks for each port are selected from four global clocks and two local clocks.

One local clock is sourced from the horizontal channel and the other from the vertical channel. The data outputs from the read port of the FIFO can also be registered. One clock polarity mux per port allows using true or complement polarity for read and write operations. The write operation is controlled by the clock and the write enable pin. The read operation is controlled by the clock and the read enable pin. The enable pins can be sourced from horizontal or vertical channels.

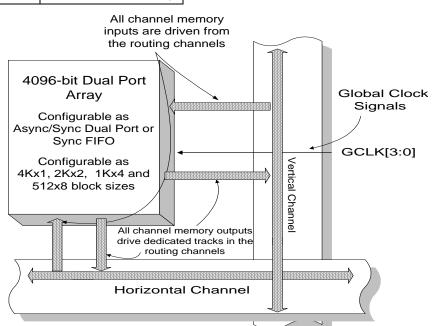


Figure 6. Block Diagram of Channel Memory Block



The channel memory powers up in an undefined state, but is set to a user-defined known state during configuration. To facilitate the use of look-up-table (LUT) logic and ROM applications, the channel memory blocks can be initialized with a given set of data when the device is configured at power up. For LUT and ROM applications, the user cannot write to memory blocks.

Channel Memory Routing Interface

Similar to LBC outputs, the channel memory blocks feature dedicated tracks in the horizontal and vertical routing channels for the data outputs and the flag outputs, as shown in *Figure 6*. This allows the channel memory blocks to be expanded easily. These dedicated lines can be routed to I/O pips

panded easily. These dedicated lines can be routed to I/O pins as chip outputs or to other logic block clusters to be used in logic equations.

I/O Banks

The Delta39K interfaces the horizontal and vertical routing channels to the pins through I/O banks. There are 8 I/O banks per device as shown in *Figure 7*, and all I/Os from an I/O bank are located in the same section of a package for PCB layout convenience.

For each package type, Delta39K devices of different densities keep given pins in the same I/O banks. This supports and simplifies design migration across densities.

Each I/O bank contains several I/O cells, and each I/O cell contains an input/output register, an output enable register, programmable slew rate control and programmable bus hold control logic. Each I/O cell drives a pin output of the device; the cell also supplies an input to the device that connects to a dedicated track in the associated routing channel.

There are four dedicated inputs (GCTI[3:0]) that are used as Global Control Signals available to every I/O cell. These global control signals may be used as output enables, register resets and register clock enables as shown in *Figure 8*.

Each I/O bank can use any supported I/O standard by supplying appropriate V_{REF} and V_{CCIO} voltages. All the V_{REF} and V_{CCIO} pins in an I/O bank must be connected to the same V_{REF} and V_{CCIO} voltage respectively. This requirement restricts the number of I/O standards supported by an I/O bank at any given time.

The number of I/Os which can be used in each I/O bank depend on the type of I/O standards and the number of V_{CCIO} and GND pins being used. This restriction is derived from the electromigration limit of the V_{CCIO} and GND bussing on the chip. Please refer to the note on page 17 and the application

note titled "Delta39K Family Device I/O Standards and Configurations" for details.

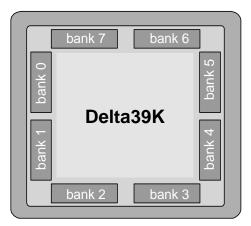


Figure 7. Delta39K I/O Bank Block Diagram

I/O Standards

I/O Standard	V _{RE}	_F (V)	V _{CCIO}	Termination Voltage (V _{TT})
	Min.	Max.		
LVTTL	N	/A	3.3V	N/A
LVCMOS			3.3V	N/A
LVCMOS3			3.0V	N/A
LVCMOS2			2.5V	N/A
LVCMOS18			1.8V	N/A
3.3V PCI			3.3V	N/A
GTL+	0.9	1.1	N/A	1.5
SSTL3 I	1.3	1.7	3.3V	1.5
SSTL3 II	1.3	1.7	3.3V	1.5
SSTL2 I	1.15	1.35	2.5V	1.25
SSTL2 II	1.15	1.35	2.5V	1.25
HSTL I	0.68	0.9	1.5V	0.75
HSTL II	0.68	0.9	1.5V	0.75
HSTL III	0.68	0.9	1.5V	1.5
HSTL IV	0.68	0.9	1.5V	1.5



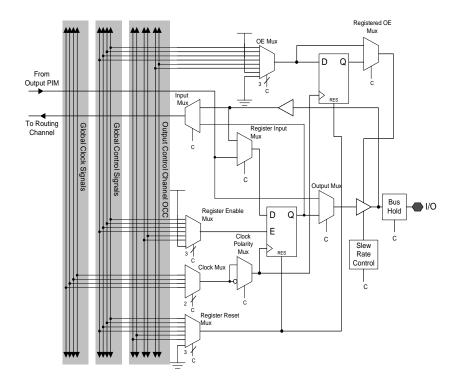


Figure 8. Block Diagram of I/O Cell

I/O Cell

Figure 8 is a block diagram of the Delta39K I/O cell. The I/O cell contains a three-state input buffer, an output buffer, and a register that can be configured as an input or output register. The output buffer has a slew rate control option that can be used to configure the output for a slower slew rate. The input of the device and the pin output can each be configured as registered or combinatorial; however, only one path can be configured as registered in a given design.

The output enable can be selected from one of the four global control signals or from one of two Output Control Channel (OCC) signals. The output enable can be configured as always enabled or always disabled or it can be controlled by one of the remaining inputs to the mux. The selection is done via a mux that includes V_{CC} and GND as inputs.

One of the global clocks can be selected as the clock for the I/O cell register. The clock mux output is an input to a clock polarity mux that allows the input/output register to be clocked on either edge of the clock.

Slew Rate Control

The ouput buffer has a slew rate control option. This allows the output buffer to slew at a fast rate (3 V/ns) or a slow rate (1 V/ns). All I/Os default to fast slew rate. For designs concerned with meeting FCC emissions standards the slow edge provides for lower system noise. For designs requiring very high performance the fast edge rate provides maximum system performance.

Programmable Bus Hold

On each I/O pin, user-programmable-bus-hold is included. Bus-hold, which is an improved version of the popular internal pull-up resistor, is a weak latch connected to the pin that does not degrade the device's performance. As a latch, bus-hold maintains the last state of a pin when the pin is placed in a high-impedance state, thus reducing system noise in bus-interface applications. Bus-hold additionally allows unused device pins to remain unconnected on the board, which is particularly useful during prototyping as designers can route new signals to the device without cutting trace connections to V_{CC} or GND. For more information, see the application note "Understanding Bus-Hold – A Feature of Cypress CPLDs."

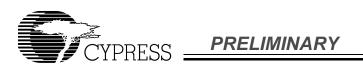
Clocks

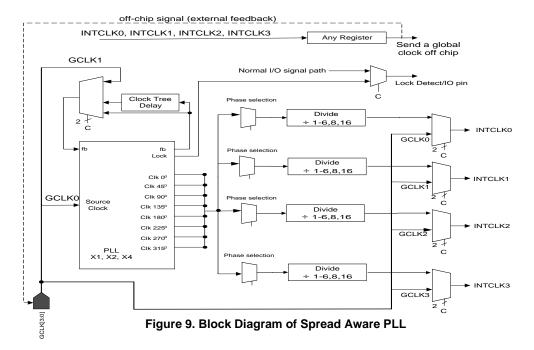
Delta39K has four dedicated clock input pins (GCLK[3:0]) to accept system clocks. One of these clocks (GCLK[0]) may be selected to drive an on-chip Phase-Locked Loop (PLL) for frequency modulation (see *Figure 9* for details).

The global clock tree for a Delta39K device can be driven by a combination of the dedicated clock pins and/or the PLL-derived clocks. The global clock tree consists of four global clocks that go to every macrocell, memory block, and I/O cell.

Clock Tree Distribution

The global clock tree performs two primary functions. First, the clock tree generates the four global clocks by multiplexing four dedicated clocks from the package pins and four PLL driven clocks. Second, the clock tree distributes the four global clocks to every cluster, channel memory, and I/O block on the die. The global clock tree is designed such that the clock skew is minimized while maintaining an acceptable clock delay.





Spread Aware[™] PLL

Each device in the Delta39K family features an on-chip PLL designed using Spread Aware technology for low EMI applications. In general, PLLs are used to implement time-division-multiplex circuits to achieve higher performance with fewer device resources.

For example, a system that operates on a 32-bit data path that runs at 40 MHz can be implemented with 16-bit circuitry that runs internally at 80 MHz. PLLs can also be used to take advantage of the positioning of the internally generated clock edges to shift performance towards improved setup, hold or clock-to-out times.

There are several frequency multiply (X1, X2, X4) and divide (/1, /2, /3, /4, /5, /6. /8, /16) options available to create a wide range of clock frequencies from a single clock input (GCLK[0]). For increased flexibility, there are seven phase shifting options which allow clock skew/de-skew by 45°, 90°, 135°, 180°, 225°, 270° or 315°.

The Voltage Controlled Oscillator (VCO), the core of the Delta39K PLL is designed to operate within the frequency range of 100 MHz to 266 MHz. Hence, the multiply option combined with input (GCLK[0]) frequency should be selected such that this VCO operating frequency requirement is met. This is demonstrated in *Table 2* (columns 1, 2, and 3).

Another feature of this PLL is the ability to drive the output clock (INTCLK) off the Delta39K chip to clock other devices on the board, as shown in *Figure 9* above. This off-chip clock is half the frequency of the output clock as it has to go through a register (I/O register or a macrocell register).

This PLL can also be used for board de-skewing purpose by driving a PLL output clock off-chip, routing it to the other devices on the board and feeding it back to the PLL's external feedback input (GCLK[1]). When this feature is used, only limited multiply, divide and phase shift options can be used.

Table 2 describes the valid multiply and divide options that can be used without an external feedback. *Table 3* describes the valid multiply & divide options that can be used with an external feedback.

Input Frequency	Valid Multiply Options		Valid Divide Options					
(GCLK[0]) f _{PLLI} (MHz)	Value	VCO Output Frequency (MHz)	Value	Output Frequency (INTCLK[3:0]) f _{PLLO} (MHz)	Off-chip Clock Frequency			
25–33	4	100–133	1–6, 8, 16	6.25–133	3.12–66			
33–50	4	133–200	1–6, 8, 16	8.33–200	4.16–100			
50-66	4	200–266	1–6, 8, 16	12.5–266	6.25–133			
	2	100–133	1–6, 8, 16	6.25–133	3.12–66			
66–100	2	133–200	1–6, 8, 16	8.3–200	4.16–100			
100–133	2	200–266	1–6, 8, 16	12.5–266	6.25–133			
	1	100–133	1–6, 8, 16	6.25–133	3.12–66			

 Table 2. PLL Multiply and Divide Options—without External Feedback



	Valio	d Multiply Options	Valid Divide Options				
Input (GCLK) Frequency f _{PLLI} (MHz)	Value	VCO Output Frequency (MHz)	Value	Output (INTCLK) Frequency f _{PLLO} (MHz)	Off-chip Clock Frequency		
50–66	1	100–133	1	100–133	50–66		
66–100	1	133–200	1	133–200	66–100		
100–133	1	200–266	1	200–266	100–133		

Table 3. PLL Multiply and Divide Options—with External Feedback

Table 4 describes the valid phase shift options that can be used with or without an external feedback.

Table 4. PLL Phase Shift Options with and without External Feedback

Without External Feedback	With External Feedback
0°,45°, 90°, 135°, 180°, 225°, 270°, 315°	0°

Table 5 is an example of the effect of all the available divide and phase shift options on a VCO output of 250 MHz. It also shows the effect of division on the duty cycle of the resultant clock. Note that the duty cycle is 50-50 when a VCO output is divided by an even number. Also note that the phase shift applies to the VCO output and not to the divided output.

The Spread Aware PLL operates as specified for Delta39KV devices (2.5V/3.3V), but not Delta39KZ devices (1.8V). For more details on the architecture and operation of this PLL please refer to the application note entitled "Delta39K PLL and Clock Tree."

Table 5. Timing of Clock Phases for all Divide Options for a VCO Output Frequency of 250 MHz

Divide Factor	Period (ns)	Duty Cy- cle%	0° (ns)	45° (ns)	90° (ns)	135° (ns)	180° (ns)	225° (ns)	270° (ns)	315° (ns)
1	4	40-60	0	0.5	1.0	1.5	2.0	2.5	3.0	3.5
2	8	50	0	0.5	1.0	1.5	2.0	2.5	3.0	3.5
3	12	33-67	0	0.5	1.0	1.5	2.0	2.5	3.0	3.5
4	16	50	0	0.5	1.0	1.5	2.0	2.5	3.0	3.5
5	20	40-60	0	0.5	1.0	1.5	2.0	2.5	3.0	3.5
6	24	50	0	0.5	1.0	1.5	2.0	2.5	3.0	3.5
8	32	50	0	0.5	1.0	1.5	2.0	2.5	3.0	3.5
16	64	50	0	0.5	1.0	1.5	2.0	2.5	3.0	3.5



Timing Model

One important feature of the Delta39K family is the simplicity of its timing. All combinatorial and registered/synchronous delays are worst case and system performance is static (as shown in the AC specs section) as long as data is routed through the same horizontal and vertical channels. *Figure 10* illustrates the true timing model for the 200-MHz devices. For synchronous clocking of macrocells, a delay is incurred from macrocell clock to macrocell clock of separate Logic Blocks within the same cluster, as well as separate Logic Blocks within different clusters. This is respectively shown as t_{SCS2} and t_{SCS2} in *Figure 10*. For combinatorial paths, any input to any output (from corner to corner on the device), incurs a worst-case delay in the 39K100 regardless of the amount of logic or which horizontal and vertical channels are used. This is the t_{PD}

shown in *Figure 10.* For synchronous systems, the input setup time to the output macrocell register and the clock to output time are shown as the parameters t_{MCS} and t_{MCCO} shown in the *Figure 10.* These measurements are for any output and synchronous clock, regardless of the logic placement.

The Delta39K features:

- no dedicated vs. I/O pin delays
- no penalty for using 0–16 product terms
- no added delay for steering product terms
- no added delay for sharing product terms
- · no output bypass delays

The simple timing model of the Delta39K family eliminates unexpected performance penalties.

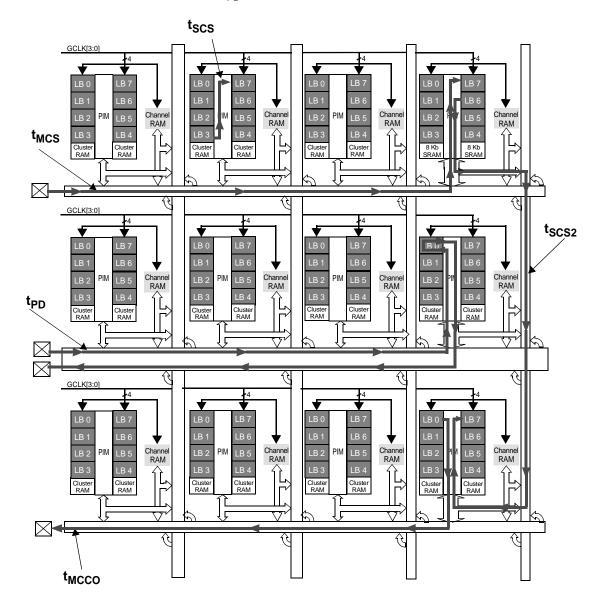
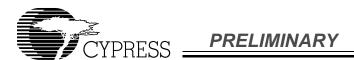


Figure 10. Timing Model for 39K100 Device



IEEE 1149.1 Compliant JTAG Operation

The Delta39K family has an IEEE 1149.1 JTAG interface for both Boundary Scan and ISR operations.

Four dedicated pins are reserved on each device for use by the Test Access Port (TAP).

Boundary Scan

The Delta39K family supports Bypass, Sample/Preload, Extest, Intest, Idcode and Usercode boundary scan instructions. The JTAG interface is shown in *Figure 11*.

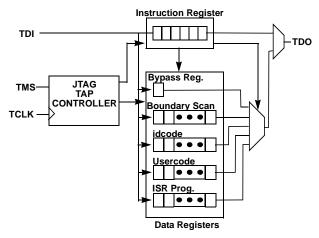


Figure 11. JTAG Interface

In-System Reprogramming (ISR)

In-System Reprogramming is the combination of the capability to program or reprogram a device on-board, and the ability to support design changes without changing the system timing or device pinout. This combination means design changes during debug or field upgrades do not cause board respins. The Delta39K family implements ISR by providing a JTAG compliant interface for on-board programming, robust routing resources for pinout flexibility, and a simple timing model for consistent system performance.

Configuration

Each device of the Delta39K family is available in a volatile and a Self-Boot package. Cypress's CPLD boot EEPROM is used to store configuration data for the volatile solution and an embedded on-chip FLASH memory device is used for the Self-Boot solution.

For volatile Delta39K packages, programming is defined as the loading of a user's design into the external CPLD boot EEPROM. For Self-Boot Delta39K packages, programming is defined as the loading of a user's design into the on-chip FLASH internal to the Delta39K package. Configuration is defined as the loading of a user's design into the Delta39K die.

Configuration can begin in two ways. It can be initiated by toggling the *Reconfig* pin from LOW to HIGH, or by issuing the appropriate IEEE std 1149.1 JTAG instruction to the Delta39K device via the JTAG interface. There are two IEEE std 1149.1 JTAG instructions that initiate configuration of the Delta39K. The *Self Config* instruction causes the Delta39K to (re)configure with data stored in the serial boot PROM or the embedded FLASH memory. The *Load Config* instruction causes the Delta39K to (re)configure according to data provided by other sources such as a PC, automatic test equipment (ATE), or an embedded micro-controller/processor via the JTAG interface. For more information on configuring Delta39K devices, refer to the application note titled "Configuring Delta39K/Quantum38K" application note at http://www.cypress.com.

There are two configuration options available for issuing the IEEE std 1149.1 JTAG instructions to the Delta39K. The first method is to use a PC with the C3ISR programming cable and software. With this method, the ISR pins of the Delta39K devices in the system are routed to a connector at the edge of the printed circuit board. The C3ISR programming cable is then connected between the PC and this connector. A simple configuration file instructs the ISR software of the programming operations to be performed on the Delta39K devices in the system. The ISR software then automatically completes all of the necessary data manipulations required to accomplish configuration, reading, verifying, and other ISR functions. For more information on the Cypress ISR interface, see the ISR Programming Kit data sheet (CY3900i).

The second configuration option for the Delta39K is to utilize the embedded controller or processor that already exists in the system. The Delta39K ISR software assists in this method by converting the device HEX file into the ISR serial stream that contains the ISR instruction information and the addresses and data of locations to be configured. The embedded controller then simply directs this ISR stream to the chain of Delta39K devices to complete the desired reconfiguration or diagnostic operations. Contact your local sales office for information on availability of this option.

Programming

The on-chip FLASH device of the Delta39K Self-Boot package is programmed by issuing the appropriate IEEE std 1149.1 JTAG instruction to the internal FLASH memory via the JTAG interface. This can be done automatically using ISR/STAPL software. The configuration bits are sent from a PC through the JTAG port into the Delta39K via the C3ISR programming cable. The data is then internally passed from Delta39K to the on-chip FLASH. For more information on how to program the Delta39K through ISR/STAPL, please refer to the ISR/STAPL User Guide.

The external CPLD boot EEPROM used to store configuration data for the Delta39K volatile package is programmed through Cypress's CYDH2200E CPLD Boot PROM Programming Kit via a two-wire interface. For more information on how to program the CPLD boot EEPROM, please refer to the data sheet titled "CYDH2200E CPLD Boot PROM Programming Kit." For more information on the architecture and timing specification of the boot EEPROM, refer to the data sheet titled "CPLD Boot EEPROM."

Third-Party Programmers

Cypress support is available on a wide variety of third-party programmers. All major programmers (including BP Micro, System General, Hi-Lo) support the Delta39K family.

Development Software Support

Warp

Warp is a state-of-the-art design environment for designing with Cypress programmable logic. Warp utilizes a subset of

IEEE 1076/1164 VHDL and IEEE 1364 as the Hardware Description Language (HDL) for design entry. *Warp* accepts VHDL or Verilog input, synthesizes and optimizes the entered design, and outputs a configuration bitstream for the desired Delta39K device. For simulation, *Warp* provides a graphical waveform simulator as well as VHDL and Verilog Timing Models.

VHDL and Verilog are open, powerful, non-proprietary Hardware Description Languages (HDLs) that are standards for behavioral design entry and simulation. HDL allows designers to learn a single language that is useful for all facets of the design process.

Third-Party Software

Cypress products are supported in a number of third-party design entry and simulation tools. Refer to the third-party software data sheet or contact your local sales office for a list of currently supported third party vendors.



Maximum Ratings

(Above which the useful life may be impaired. For user guidelines, not tested.)

Storage Temperature	–65°C to +150°C
Soldering Temperature	220°C
Ambient Temperature with Power Applied	–40°C to +85°C
Junction Temperature	135°C
V _{CC} to Ground Potential (39KZ device)	–0.5V to 2.5V

Operating Range

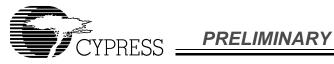
V _{CC} to Ground Potential (39KV device)0.5V to 4.6V
V _{CCIO} to Ground Potential0.5V to 4.6V
DC Voltage Applied to Outputs in High Z State –0.5V to 4.5V
DC Input voltage0.5V to 4.5V
DC Current into Outputs ±20 mA ^[6]
Static Discharge Voltage (per MIL-STD-8883,
Method 3015)>2001V
Latch-Up Current>200 mA

Range	Ambient Temperature	Junction Temperature	Output Condition	V _{CCIO}	v _{cc}	V _{CCJTAG} / V _{CCCNFG}	V _{CCPLL}	V _{CCPRG}
	0°C to +70°C	0°C to +85°C	3.3V	3.3V ± 0.3V				
Commercial			2.5V	2.5V ± 0.2V	3.3V ± 0.3V or	Same as	Same as V _{CC}	3.3V
Commercial			1.8V	1.8V ± 0.15V	2.5V ± 0.2V	V _{CCIO}		±
			1.5V	1.5V ± 0.1V ^[5]	(39KV)			0.3V
	-40°C to +85°C	-40°C to +100°C	3.3V	3.3V ± 0.3V				
Industrial			2.5V	2.5V ± 0.2V	1.8V±0.15V (39KZ)			
muusinai			1.8V	1.8V ± 0.15V	(00112)			
			1.5V	1.5V ± 0.1V ^[5]				

DC Characteristics

			V _{CCIO}	= 3.3 V	V _{CCIO}	= 2.5 V	V _{CCIO}	= 1.8 V	
Parameter	Description	Test Conditions	Min.	Max.	Min.	Max.	Min.	Max.	Unit
V _{DRINT}	Data Retention V _{CC} Voltage (config data may be lost below this)		1.5		1.5		1.5		V
V _{DRIO}	Data Retention V _{CCIO} Voltage (config data may be lost below this)		1.2		1.2		1.2		V
I _{IX}	Input Leakage Current	$GND \le V_I \le 3.6V$	-10	10	-10	10	-10	10	μA
I _{OZ}	Output Leakage Current	$GND \le V_O \le V_{CCIO}$	-10	10	-10	10	-10	10	μA
I _{OS} ^[7]	Output Short Circuit Current	V _{CCIO} = Max., V _{OUT} = 0.5V		-160		-160		-160	mA
I _{BHL}	Input Bus Hold LOW Sustaining Current	V _{CC} = Min., V _{PIN} = V _{IL}	+40		+30		+25		μΑ
I _{BHH}	Input Bus Hold HIGH Sustaining Current	V _{CC} = Min., V _{PIN} = V _{IH}	-40		-30		-25		μΑ
I _{BHLO}	Input Bus Hold LOW Overdrive Current	V _{CC} = Max.		+250		+200		+150	μΑ
I _{BHHO}	Input Bus Hold HIGH Overdrive Current	V _{CC} = Max.		-250		-200		-150	μA
Notes:		•	•	•			•	•	•

6. DC current into outputs is 36 mA with HSTL III, 48 mA with HSTL IV and 36 mA with GTL+ (with 25Ω pull-up resistor and $V_{TT} = 1.5$ 7. Not more than one output should be tested at a time. Duration of the short circuit should not exceed 1 second. $V_{OUT} = 0.5V$ has been chosen to avoid test problems caused by tester ground degradation. Tested initially and after any design or process changes that may affect these parameters.



Capacitance

Parameter	Description	Test Conditions	Min.	Max.	Unit
C _{I/O}	Input/Output Capacitance	V _{in} =V _{CCIO} @ f=1 MHz 25°C		10	pF
C _{CLK}	Clock Signal Capacitance	V _{in} =V _{CCIO} @ f=1 MHz 25°C	5	12	pF
C _{PCI}	PCI Compliant ^[8] Capacitance	V _{in} =V _{CCIO} @ f=1 MHz 25°C		8	pF

DC Characteristics (IO)^[9]

Input/	V _{REI}	_F (V)		٧c	_{он} (V)	Vo	_ (V)	V _{IH}	(V)	V _{IL} (V)		
Output Standard	Min.	Мах.	v _{ccio} (V)	@ I _{OH} =	V _{OH} (min.)	@ I _{OL} =	V _{OL} (max.)	Min.	Max.	Min.	Max.	
LVTTL	N/	/A	3.3	–4 mA	2.4	4 mA	0.4	2.0 V	V _{CCIO} +0.3	-0.3V	0.8V	
LVCMOS			3.3	–0.1 mA	V _{CCIO} -0.2v	0.1 mA	0.2	2.0 V	V _{CCIO} +0.3	-0.3V	0.8V	
LVCMOS3			3.0	–0.1 mA	V _{CCIO} -0.2v	0.1mA	0.2	2.0 V	V _{CCIO} +0.3	-0.3V	0.8V	
			2.5	–0.1 mA	2.1	0.1 mA	0.2	1.7 V	V _{CCIO} +0.3	-0.3V	0.7V	
LVCMOS2				–1.0 mA	2.0	1.0 mA	0.4					
				–2.0 mA	1.7	2.0 mA	0.7					
LVCMOS18			1.8	–0.1 mA	V _{CCIO} -0.2v	0.1mA	0.2	0.65V _{CCIO} V _{CCIO} +0.3		-0.3V	0.35V _{CCIO}	
				– 2 mA	V _{CCIO} -0.45v	2.0 mA	0.45					
3.3V PCI			3.3	–0.5 mA	0.9V _{CCIO}	1.5 mA	0.1V _{CCIO}	0.5V _{CCIO}	V _{CCIO} +0.5	-0.5V	0.3V _{CCIO}	
GTL+	0.9	1.1	Note 10			Note 11	0.6	V _{REF} +0.2			V _{REF} -0.2	
SSTL3 I	1.3	1.7	3.3	–8 mA	V _{CCIO} -1.1v	8 mA	0.7	V _{REF} +0.2	V _{CCIO} +0.3	-0.3V	V _{REF} -0.2	
SSTL3 II	1.3	1.7	3.3	–16 mA	V _{CCIO} –0.9v	16 mA	0.5	V _{REF} +0.2	V _{CCIO} +0.3	-0.3V	V _{REF} 0.2	
SSTL2 I	1.15	1.35	2.5	–7.6 mA	V _{CCIO} -0.62v	7.6 mA	0.54	V _{REF} +1.8	V _{CCIO} +0.3	-0.3V	V _{REF} 0.18	
SSTL2 II	1.15	1.35	2.5	–15.2 mA	V _{CCIO} -0.43v	15.2 mA	0.35	V _{REF} +1.8	V _{CCIO} +0.3	-0.3V	V _{REF} 0.18	
HSTL I	0.68	0.9	1.5	–8 mA	V _{CCIO} -0.4v	8 mA	0.4	V _{REF} +1.0	V _{CCIO} +0.3	-0.3V	V _{REF} 0.1	
HSTL II	0.68	0.9	1.5	–16 mA	V _{CCIO} –0.4v	16 mA	0.4	V _{REF} +1.0	V _{CCIO} +0.3	-0.3V	V _{REF} -0.1	
HSTL III	0.68	0.9	1.5	–8 mA	V _{CCIO} -0.4v	24 mA	0.4	V _{REF} +1.0	V _{CCIO} +0.3	-0.3V	V _{REF} -0.1	
HSTL IV	0.68	0.9	1.5	–8 mA	V _{CCIO} -0.4v	48 mA	0.4	V _{REF} +1.0	V _{CCIO} +0.3	–0.3V	V _{REF} -0.1	

Notes:

PCI spec (rev 2.2) requires the IDSEL pin to have capacitance less than or equal to 8 pF. Document titled "Delta39K Pin Tables" identifies all the I/O pins, in a given package, which can be used as IDSEL in a PCI design. All other I/O pins meet the PCI requirement of capacitance less than or equal to 10 pf.
 The number of I/Os which can be used in each I/O bank depends on the type of I/O standards and the number of V_{CCIO} and GND pins being used. Please refer to the application note titled "Delta39K Family Device I/O Standards and Configurations" for details.

• The source current limit per I/O bank per Vccio pin is 165 mA

• The sink current limit per I/O bank per GND pin is 230 mA 10. See "Power-up Sequence Requirements" below for V_{CCIO} requirement.

11. 25Ω resistor terminated to termination voltage of 1.5V.

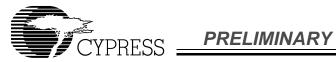


Configuration Parameters

Parameter	Description	Min.	Unit
t _{RECONFIG}	Reconfig pin LOW time before it goes HIGH	200	ns

Power-up Sequence Requirements

- Upon power-up, all the outputs remain three-stated until all the V_{CC} pins have powered-up to the nominal voltage and the part has completed configuration.
- The part will not start configuration until V_{CC}, V_{CCIO}, V_{CCJTAG}, V_{CCCNFG}, V_{CCPLL} and V_{CCPRG} have reached nominal voltage.
- V_{CC} pins can be powered up in any order. This includes V_{CC} , V_{CCIO} , V_{CCJTAG} , V_{CCCNFG} , V_{CCPLL} and V_{CCPRG} .
- All $\mathsf{V}_{\mathsf{CCIO}}\mathsf{s}$ on a bank should be tied to the same potential and powered up together.
- All V_{CCIO}s (even the unused banks) need to be powered up to at least 1.5V before configuration has completed.
- Maximum ramp time for all $V_{CC} s$ should be 0V to nominal voltage in 100 ms.

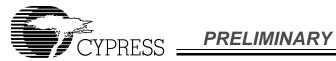


Switching Characteristics - Parameter Descriptions Over the Operating Range ^[12]

Implementation output on the horizontal or vertical channel associated with that cluster te _R Global control to output enable te _R Global control to output disable te _R Asynchronous macrocell RESET or PRESET recovery time from any pin input on the horizontal or vertical channel associated with the cluster the macrocell is in term Asynchronous macrocell RESET or PRESET remany pin input on the horizontal or vertical channel associated with the cluster that the macrocell is in to any pin output on those same channels term Asynchronous macrocell RESET or PRESET remany pin input on the same channels theR Asynchronous macrocell RESET or PRESET remany pin input on the norizontal or vertical channel associated with that input the or any control to a discover on the channel associated with that input pin relative to a global clock Spichronous Clocking Parameters Set-up time of any input pin to a macrocell in any cluster on the channel associated with that input pin, relative to a global clock tucco Global clock to output of any macrocell to any output pin on the horizontal or vertical channel associated with that pin, relative to a global clock tucco Global clock to output of any input pin to the I/O cell register associated with that pin, relative to a global clock trock tucco Global clock to macrocell clock through array logic within the same cluster tucco Clock to output of an V/o cell register clock on	Parameter	Description
PD output on the horizontal or vertical channel associated with that cluster teA Global control to output enable teR Global control to output disable teR Asynchronous macrocell RESET or PRESET reavery time from any pin input on the horizontal or vertical channel associated with the cluster the macrocell is in teRO Asynchronous macrocell RESET or PRESET from any pin input on the horizontal or vertical channel associated with the cluster that the macrocell is in to any pin output on those same channels teRW Asynchronous macrocell RESET or PRESET from any pin input on the same channels Spectronous Clocking Parameters Set-up time of any input pin to a macrocell in any cluster on the channel associated with that input pin relative to a global clock tMCC Global clock to output of any ancrocell to any output pin on the horizontal or vertical channel associated with that input pin, relative to a global clock to a global clock to a global clock to a global clock to clock to macrocell is in tMCCO Global clock to output of any input pin to the I/O cell register associated with that pin, relative to a global clock to a global clock to a global clock to clock to macrocell clock through array logic within the same cluster tioco Clock to output of an Vio cell register to the output pin associated with that register tioco Clock to output of any macrocell clock through array logic within the same cluster tioco Clock	Combinatorial M	
ER Global control to output disable tPR Asynchronous macrocell RESET or PRESET recovery time from any pin input on the horizontal or vertic channel associated with the cluster the macrocell is in on any pin input on the horizontal or vertical channel associated with the cluster that the macrocell is in to any pin output on those same channels tPRO Asynchronous macrocell RESET or PRESET from any pin input on the horizontal or vertical channel associated with the cluster that the macrocell is in to any pin output on those same channels tPRW Asynchronous macrocell RESET or PRESET minimum pulse width, from any pin input to a macrocell the faithest cluster on the horizontal or vertical channel the pin is associated with that input pin relative to a global clock Structor Set-up time of any input pin to a macrocell in any cluster on the channel associated with that input pin relative to a global clock tMCH Hold time of any input pin to a macrocell to any output pin on the horizontal or vertical channel associated with that input pin, relative to a global clock tlogs Set-up time of any input pin to the I/O cell register associated with that pin, relative to a global clock to output of an I/O cell register to the output pin associated with that register tlogs Det-up time of any input pin to the I/O cell register associated with that pin, relative to a global clock to Global clock to to acrocell clock through array logic in different clusters on the same channel tlogs Det-up time of any macrocell clock through array logic in different clusters on the same channel <td>t_{PD}</td> <td>Delay from any pin input, through any cluster on the channel associated with that pin input, to any pin output on the horizontal or vertical channel associated with that cluster</td>	t _{PD}	Delay from any pin input, through any cluster on the channel associated with that pin input, to any pin output on the horizontal or vertical channel associated with that cluster
Asynchronous macrocell RESET or PRESET recovery time from any pin input on the horizontal or vertic channel associated with the cluster the macrocell is in associated with the cluster that the macrocell is in to any pin output on the horizontal or vertical channel associated with the cluster that the macrocell is in to any pin output on these same channels term Asynchronous macrocell RESET or PRESET minimum pulse width, from any pin input to a macrocell the farthest cluster on the horizontal or vertical channel the pin is associated with Synchronous Clocking Parameters Set-up time of any input pin to a macrocell in any cluster on the channel associated with that input pin relative to a global clock McCH Hold time of any input pin to a macrocell in any cluster on the channel associated with that input pin, relative to a global clock MucCH Hold time of any input pin to the No cell register associated with that pin, relative to a global clock MucCH Hold time of any input pin to the I/O cell register associated with that pin, relative to a global clock MucCO Clock to output of an I/O cell register associated with that pin, relative to a global clock MucCO Clock to output of an I/O cell register ot the channel that register Macrocell clock to macrocell clock through array logic within the same cluster Macrocell clock to any macrocell clock through array logic within the same cluster Macrocell clock to any I/O register clock on the horizontal or vertical channel associated with to cs Macro	t _{EA}	Global control to output enable
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IPRO associated with the cluster that the macrocell is in to any pin output on those same channels t _{PRW} Asynchronous macrocell RESET or PRESET minimum pulse with, from any pin input to a macrocell the farthest cluster on the horizontal or vertical channel the pin is associated with that input pin relative to a global clock Synchronous Clocking Parameters Set-up time of any input pin to a macrocell in any cluster on the channel associated with that input pin, relative to a global clock fMCH Hold time of any input pin to a macrocell in any cluster on the channel associated with that input pin, relative to a global clock tMCC0 Global clock to output of any macrocell to any output pin on the horizontal or vertical channel associated with that pin, relative to a global clock tMCC0 Global clock to output of any macrocell to any output pin to the horizontal or vertical channel associated with that pin, relative to a global clock tMCC0 Clock to output of an /input pin to the I/O cell register associated with that pin, relative to a global clock to accocell clock to macrocell clock through array logic within the same cluster t _{QCC0} Clock to output of an //O cell register of the output pin associated with that register t _{SCS2} Macrocell clock to macrocell clock in a cluster on the channel the I/O register is associated with the cluster t _{QCC0} Clock to any I/O register clock on the horizontal or vertical channel associated with the cluster t _{QCS2} Macrocell c	t _{PRR}	Asynchronous macrocell RESET or PRESET recovery time from any pin input on the horizontal or vertical channel associated with the cluster the macrocell is in
UPRW The farthest cluster on the horizontal or vertical channel ihe pin is associated with Synchronous Clocking Parameters MCS Set-up time of any input pin to a macrocell in any cluster on the channel associated with that input pin relative to a global clock tMCH Hold time of any input pin to a macrocell in any cluster on the channel associated with that input pin, relative to a global clock tMCCO Global clock to output of any macrocell to any output pin on the horizontal or vertical channel associated with the cluster that macrocell is in tross Set-up time of any input pin to the I/O cell register associated with that pin, relative to a global clock too tros Set-up time of any input pin to the I/O cell register associated with that pin, relative to a global clock to clock to do any input pin to the I/O cell register associated with that pin, relative to a global clock to a global clock to clock to macrocell clock through array logic within the same cluster tscss Macrocell clock to macrocell clock through array logic within the same cluster ttcs I/O register clock to any MC register clock on the horizontal or vertical channel associated with the clust that the macrocell clock to any MC register clock on the horizontal or vertical channel associated with the clust that the macrocell clock to any MC register clock on the horizontal or vertical channel associated with the clust that the macrocell clock to any MC register clock on the horizontal or vertical channel associated with the clust that the macrocell is in tCLS Maco	t _{PRO}	Asynchronous macrocell RESET or PRESET from any pin input on the horizontal or vertical channel associated with the cluster that the macrocell is in to any pin output on those same channels
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^{tMCS} relative to a global clock t _{MCH} Hold time of any input pin to a macrocell in any cluster on the channel associated with that input pin, relative to a global clock t _{MCCO} Global clock to output of any macrocell to any output pin on the horizontal or vertical channel associated with the cluster that macrocell is in t _{IOS} Set-up time of any input pin to the I/O cell register associated with that pin, relative to a global clock t _{IOH} Hold time of any input pin to the I/O cell register associated with that pin, relative to a global clock t _{IOCO} Clock to output of an I/O cell register to the output pin associated with that register t _{SCS} Macrocell clock to macrocell clock through array logic within the same cluster t _{SCS2} Macrocell clock to any I/O register clock on the channel the I/O register is associated with the cluster state macrocell is in t _{CCS} I/O register clock to any I/O register clock on the horizontal or vertical channel associated with the cluster that the macrocell is in t _{CLZ} Clock to output disable (high-impedance) t _{CLZ} Clock to output disable (high-impedance) t _{CLZ} Clock to output enable (low-impedance) t _{MAX2} Maximum frequency with internal feedback—within different clusters at the opposite ends of a horizon or vertical channel Product Term Clock Maximum frequency with internal feedback—within different cl	Synchronous Cl	ocking Parameters
MCH to a global clock tMCCO Global clock to output of any macrocell to any output pin on the horizontal or vertical channel associat with the cluster that macrocell is in tloS Set-up time of any input pin to the I/O cell register associated with that pin, relative to a global clock to clock to output of an I/O cell register associated with that pin, relative to a global clock tloH Hold time of any input pin to the I/O cell register associated with that pin, relative to a global clock to clock to output of an I/O cell register to the output pin associated with that register tscs Macrocell clock to macrocell clock through array logic within the same cluster tscs2 Macrocell clock to any macrocell clock in a cluster on the channel the I/O register is associated with the clust that the macrocell is in tCcs I/O register clock to any I/O register clock on the horizontal or vertical channel associated with the clust that the macrocell is in tCLZ Clock to output disable (high-impedance) tCLZ Clock to output enable (low-impedance) fMAX2 Maximum frequency with internal feedback—within the same cluster fMAX2 Maximum frequency with internal feedback—within different clusters at the opposite ends of a horizon or vertical channel fMAX2 Product Term Clock tMcCoPT Product term clock to output deal pfrom input pin tMcCoPT Product term clock to output deal pfr	t _{MCS}	Set-up time of any input pin to a macrocell in any cluster on the channel associated with that input pin, relative to a global clock
MCCO with the cluster that macrocell is in t _{IOS} Set-up time of any input pin to the I/O cell register associated with that pin, relative to a global clock t _{IOH} Hold time of any input pin to the I/O cell register associated with that pin, relative to a global clock t _{IOCO} Clock to output of an I/O cell register to the output pin associated with that register t _{SCS} Macrocell clock to macrocell clock through array logic within the same cluster t _{SCS2} Macrocell clock to any macrocell clock in a cluster on the channel the I/O register is associated with t _{ICS} I/O register clock to any macrocell clock on the horizontal or vertical channel associated with the clust that the macrocell is in t _{ICS} I/O register clock to any I/O register clock on the horizontal or vertical channel associated with the clust that the macrocell is in t _{CLZ} Clock to output enable (high-impedance) t _{CLZ} Clock to output with internal feedback—within the same cluster f _{MAX2} Maximum frequency with internal feedback—within different clusters at the opposite ends of a horizon or vertical channel f _{MAX2} Set-up time for macrocell used as input register, from input to product term clock t _{MCOPT} Product term clock to output delay from input pin t _{MCCOPT} Product term clock to output delay from input pin t _{SCS2PT} Registe	t _{MCH}	Hold time of any input pin to a macrocell in any cluster on the channel associated with that input pin, relative to a global clock
Hold time of any input pin to the I/O cell register associated with that pin, relative to a global clock tiOCO Clock to output of an I/O cell register to the output pin associated with that register tSCS Macrocell clock to macrocell clock through array logic within the same cluster tSCS2 Macrocell clock to any macrocell clock through array logic in different clusters on the same channel tICS I/O register clock to any macrocell clock in a cluster on the channel the I/O register is associated with that the macrocell is in tCLZ Clock to output disable (high-impedance) tCLZ Clock to output enable (low-impedance) fMAX2 Maximum frequency with internal feedback—within the same cluster fMAX2 Maximum frequency with internal feedback—within different clusters at the opposite ends of a horizon or vertical channel fMAX2 Maximum frequency with internal feedback—within different clusters at the opposite ends of a horizon or vertical channel fMAX2 Maximum frequency with internal feedback—within different clusters at the opposite ends of a horizon or vertical channel FMAX2 Maximum frequency with internal feedback—within different clusters at the opposite ends of a horizon or vertical channel FMAX2 Maximum frequency with internal feedback—within different clusters at the opposite ends of a horizon or vertical channel FMAX2 Maximum frequency matcrocell used as input registe	t _{MCCO}	Global clock to output of any macrocell to any output pin on the horizontal or vertical channel associated with the cluster that macrocell is in
Clock to output of an I/O cell register to the output pin associated with that register t _{IOCO} Clock to output of an I/O cell register to the output pin associated with that register t _{SCS} Macrocell clock to macrocell clock through array logic within the same cluster t _{SCS2} Macrocell clock to any macrocell clock through array logic in different clusters on the same channel t _{ICS} I/O register clock to any macrocell clock in a cluster on the channel the I/O register is associated with tocs t _{CLZ} Clock to output disable (high-impedance) t _{CLZ} Clock to output enable (low-impedance) t _{CLZ} Clock to output metable (low-impedance) t _{MAX2} Maximum frequency with internal feedback—within the same cluster f _{MAX2} Maximum frequency with internal feedback—within different clusters at the opposite ends of a horizon or vertical channel Product Term Clock t t _{MCSPT} Set-up time for macrocell used as input register, from input to product term clock t _{MCHPT} Hold time of macrocell used as an input register t _{MCCOPT} Product term clock to output delay from input pin t _{SCS2PT} Register to register delay through array logic in different clusters on the same channel using a product term clock Channel Intercon-ect Parameters Adder for a signal to switch from a horizontal	t _{IOS}	Set-up time of any input pin to the I/O cell register associated with that pin, relative to a global clock
tscs Macrocell clock to macrocell clock through array logic within the same cluster tscs Macrocell clock to macrocell clock through array logic in different clusters on the same channel tics I/O register clock to any macrocell clock in a cluster on the channel the I/O register is associated with tocs Macrocell clock to any macrocell clock on the horizontal or vertical channel associated with the clust that the macrocell is in tCHZ Clock to output disable (high-impedance) tCLZ Clock to output enable (low-impedance) fMAX Maximum frequency with internal feedback—within the same cluster fMAX2 Maximum frequency with internal feedback—within different clusters at the opposite ends of a horizon or vertical channel FMAX2 Set-up time for macrocell used as input register, from input to product term clock tMCHPT Hold time of macrocell used as an input register tMCCOPT Product term clock to output delay from input pin tscs22 Register to register delay through array logic in different clusters on the same channel using a product term clock Channel Intercontert Parameters Adder for a signal to switch from a horizontal to vertical channel and vice-versa	t _{IOH}	Hold time of any input pin to the I/O cell register associated with that pin, relative to a global clock
tscs2 Macrocell clock to macrocell clock through array logic in different clusters on the same channel tics t/O register clock to any macrocell clock in a cluster on the channel the I/O register is associated with tocs Macrocell clock to any I/O register clock on the horizontal or vertical channel associated with the clust that the macrocell is in tcHz Clock to output disable (high-impedance) tcHz Clock to output enable (low-impedance) fMAX Maximum frequency with internal feedback—within the same cluster fMAX Maximum frequency with internal feedback—within different clusters at the opposite ends of a horizon or vertical channel Product Term Clock Maccoell used as input register, from input to product term clock tMCCPT Product term clock to output delay from input pin tscs2PT Register to register delay through array logic in different clusters on the same channel using a product ter clock Channel Intercontect Parameters Adder for a signal to switch from a horizontal to vertical channel and vice-versa	t _{IOCO}	Clock to output of an I/O cell register to the output pin associated with that register
tics I/O register clock to any macrocell clock in a cluster on the channel the I/O register is associated with tocs Macrocell clock to any I/O register clock on the horizontal or vertical channel associated with the clust that the macrocell is in t _{CHZ} Clock to output disable (high-impedance) t _{CLZ} Clock to output enable (low-impedance) f _{MAX} Maximum frequency with internal feedback—within the same cluster f _{MAX} Maximum frequency with internal feedback—within different clusters at the opposite ends of a horizon or vertical channel Product Term Clock t t _{MCSPT} Set-up time for macrocell used as input register, from input to product term clock t _{MCCPT} Hold time of macrocell used as an input register t _{MCCOPT} Product term clock to output delay from input pin t _{SCS2PT} Register to register delay through array logic in different clusters on the same channel using a product ter clock Channel Intercontext Parameters t t _{CHSW} Adder for a signal to switch from a horizontal to vertical channel and vice-versa	t _{SCS}	Macrocell clock to macrocell clock through array logic within the same cluster
tocs Macrocell clock to any I/O register clock on the horizontal or vertical channel associated with the clust that the macrocell is in t _{CHZ} Clock to output disable (high-impedance) t _{CLZ} Clock to output enable (low-impedance) f _{MAX} Maximum frequency with internal feedback—within the same cluster f _{MAX2} Maximum frequency with internal feedback—within different clusters at the opposite ends of a horizon or vertical channel Product Term Clock Macrocell used as input register, from input to product term clock t _{MCNPT} Hold time of macrocell used as an input register t _{MCCOPT} Product term clock to output delay from input pin t _{SCS2PT} Register to register delay through array logic in different clusters on the same channel using a product term clock Channel Interconnect Parameters Adder for a signal to switch from a horizontal to vertical channel and vice-versa	t _{SCS2}	Macrocell clock to macrocell clock through array logic in different clusters on the same channel
IOCS that the macrocell is in t _{CHZ} Clock to output disable (high-impedance) t _{CLZ} Clock to output enable (low-impedance) f _{MAX} Maximum frequency with internal feedback—within the same cluster f _{MAX2} Maximum frequency with internal feedback—within different clusters at the opposite ends of a horizon or vertical channel Product Term Clock Maximum frequency with internal feedback—within different clusters at the opposite ends of a horizon or vertical channel Product Term Clock Maximum frequency with internal feedback—within different clusters at the opposite ends of a horizon or vertical channel Product Term Clock Maximum frequency with internal feedback—within different clusters at the opposite ends of a horizon or vertical channel Product Term Clock Maximum frequency with internal feedback—within different clusters at the opposite ends of a horizon or vertical channel Product Term Clock Maximum frequency with internal feedback—within different clusters on the clock t _{MCSPT} Set-up time for macrocell used as an input register t _{MCCOPT} Product term clock to output delay from input pin t _{SCS2PT} Register to register delay through array logic in different clusters on the same channel using a product term clock Channel Intercon-ct Parameters Adder for a signal to switch from a horizontal to vertical channel and vice-versa	t _{ICS}	I/O register clock to any macrocell clock in a cluster on the channel the I/O register is associated with
tcLz Clock to output enable (low-impedance) f _{MAX} Maximum frequency with internal feedback—within the same cluster f _{MAX2} Maximum frequency with internal feedback—within different clusters at the opposite ends of a horizon or vertical channel Product Term Clock Maximum for macrocell used as input register, from input to product term clock t _{MCCPT} Set-up time for macrocell used as an input register t _{MCCOPT} Product term clock to output delay from input pin t _{SCS2PT} Register to register delay through array logic in different clusters on the same channel using a product ter clock Channel Intercontert Parameters Adder for a signal to switch from a horizontal to vertical channel and vice-versa	tocs	Macrocell clock to any I/O register clock on the horizontal or vertical channel associated with the cluster that the macrocell is in
t _{CLZ} Clock to output enable (low-impedance) f _{MAX} Maximum frequency with internal feedback—within the same cluster f _{MAX2} Maximum frequency with internal feedback—within different clusters at the opposite ends of a horizon or vertical channel Product Term Clock Maximum for macrocell used as input register, from input to product term clock t _{MCSPT} Set-up time for macrocell used as an input register, from input to product term clock t _{MCHPT} Hold time of macrocell used as an input register t _{MCCOPT} Product term clock to output delay from input pin t _{SCS2PT} Register to register delay through array logic in different clusters on the same channel using a product term clock Channel Interconvect Parameters Adder for a signal to switch from a horizontal to vertical channel and vice-versa	t _{CHZ}	Clock to output disable (high-impedance)
Maximum frequency with internal feedback—within different clusters at the opposite ends of a horizon or vertical channel Product Term Clock t _{MCSPT} Set-up time for macrocell used as input register, from input to product term clock t _{MCHPT} Hold time of macrocell used as an input register t _{MCCOPT} Product term clock to output delay from input pin t _{SCS2PT} Register to register delay through array logic in different clusters on the same channel using a product term clock Channel Intercon-ct Parameters Adder for a signal to switch from a horizontal to vertical channel and vice-versa		Clock to output enable (low-impedance)
IMAX2 or vertical channel Product Term Clock t _{MCSPT} Set-up time for macrocell used as input register, from input to product term clock t _{MCHPT} Hold time of macrocell used as an input register t _{MCCOPT} Product term clock to output delay from input pin t _{SCS2PT} Register to register delay through array logic in different clusters on the same channel using a product ter clock Channel Interconvect Parameters Adder for a signal to switch from a horizontal to vertical channel and vice-versa	f _{MAX}	Maximum frequency with internal feedback—within the same cluster
t _{MCSPT} Set-up time for macrocell used as input register, from input to product term clock t _{MCHPT} Hold time of macrocell used as an input register t _{MCCOPT} Product term clock to output delay from input pin t _{SCS2PT} Register to register delay through array logic in different clusters on the same channel using a product ter clock Channel Intercomect Parameters Adder for a signal to switch from a horizontal to vertical channel and vice-versa	f _{MAX2}	Maximum frequency with internal feedback—within different clusters at the opposite ends of a horizontal or vertical channel
Image: Product term Hold time of macrocell used as an input register t _{MCCPT} Product term clock to output delay from input pin t _{SCS2PT} Register to register delay through array logic in different clusters on the same channel using a product ter clock Channel Interconnect Parameters Adder for a signal to switch from a horizontal to vertical channel and vice-versa t _{CHSW} Adder for a signal to switch from a horizontal to vertical channel and vice-versa	Product Term CI	ock
t _{MCHPT} Hold time of macrocell used as an input register t _{MCCOPT} Product term clock to output delay from input pin t _{SCS2PT} Register to register delay through array logic in different clusters on the same channel using a product ter clock Channel Intercon- t _{CHSW} Adder for a signal to switch from a horizontal to vertical channel and vice-versa	t _{MCSPT}	Set-up time for macrocell used as input register, from input to product term clock
t _{MCCOPT} Product term clock to output delay from input pin t _{SCS2PT} Register to register delay through array logic in different clusters on the same channel using a product te clock Channel Interconnect Parameters Adder for a signal to switch from a horizontal to vertical channel and vice-versa		Hold time of macrocell used as an input register
tscs2PT Register to register delay through array logic in different clusters on the same channel using a product to clock Channel Interconnect Parameters Adder for a signal to switch from a horizontal to vertical channel and vice-versa tcHSW Adder for a signal to switch from a horizontal to vertical channel and vice-versa		Product term clock to output delay from input pin
t _{CHSW} Adder for a signal to switch from a horizontal to vertical channel and vice-versa		Register to register delay through array logic in different clusters on the same channel using a product term clock
	Channel Interco	nnect Parameters
	t _{CHSW}	Adder for a signal to switch from a horizontal to vertical channel and vice-versa
	t _{CL2CL}	Cluster to Cluster delay adder (through channels and channel PIM)

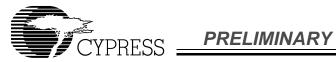
Note:

12. Add t_{CHSW} to signals making a horizontal to vertical channel switch or vice-versa.



Switching Characteristics - Parameter Descriptions Over the Operating Range ^[12] (continued)

Parameter	Description
Miscellaneous I	Delays
t _{CPLD}	Delay from the input of a cluster PIM, through a macrocell in the cluster, back to a cluster PIM input. This parameter can be added to the t_{PD} and t_{SCS} parameters for each extra pass through the AND/OR array required by a given signal path
t _{MCCD}	Adder for carry chain logic per macrocell
t _{IOD}	Delay from the input of the output buffer to the I/O pin
t _{IOIN}	Delay from the I/O pin to the input of the channel buffer
t _{CKIN}	Delay from the clock pin to the input of the clock driver
t _{IOREGPIN}	Delay from the I/O pin to the input of the I/O register
PLL Parameters	
t _{MCCJ}	Maximum cycle to cycle jitter time
t _{DWSA}	PLL delay with skew adjustment
t _{DWOSA}	PLL delay without any skew adjustment
t _{LOCK}	Lock time for the PLL
f _{PLLO}	Output frequency of the PLL
f _{PLLI}	Input frequency of the PLL
JTAG Paramete	rs
t _{JCKH}	TCLK HIGH time
t _{JCKL}	TCLK LOW time
t _{JCP}	TCLK clock period
t _{JSU}	JTAG port setup time (TDI/TMS inputs)
t _{JH}	JTAG port hold time (TDI/TMS inputs)
t _{JCO}	JTAG port clock to output time (TDO)
t _{JXZ}	JTAG port valid output to high impedance (TDO)
t _{JZX}	JTAG port high impedance to valid output (TDO)



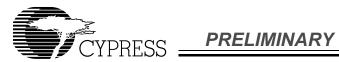
Cluster Memory Timing Parameter Descriptions Over the Operating Range

Parameter	Description
Asynchronous	Mode Parameters
t _{CLMAA}	Cluster memory access time. Delay from address change to read data out
t _{CLMPWE}	Write Enable pulse width
t _{CLMSA}	Address set-up to the beginning of Write Enable with both signals from the same I/O block
t _{CLMHA}	Address hold after the end of Write Enable with both signals from the same I/O block
t _{CLMSD}	Data set-up to the end of Write Enable
t _{CLMHD}	Data hold after the end of Write Enable
Synchronous Mo	ode Parameters
t _{CLMCYC1}	Clock cycle time for flow through read and write operations (from macrocell register through cluster memory back to a macrocell register in the same cluster)
t _{CLMCYC2}	Clock cycle time for pipelined read and write operations (from cluster memory input register through the memory to cluster memory output register)
t _{CLMS}	Address, data, and WE set-up time of pin inputs, relative to a global clock
t _{CLMH}	Address, data, and WE hold time of pin inputs, relative to a global clock
t _{CLMDV1}	Global clock to data valid on output pins for flow through data
t _{CLMDV2}	Global clock to data valid on output pins for pipelined data
t _{CLMMACS1}	Cluster memory input clock to macrocell clock in the same cluster
t _{CLMMACS2}	Cluster memory output clock to macrocell clock in the same cluster
t _{MACCLMS1}	Macrocell clock to cluster memory input clock in the same cluster
t _{MACCLMS2}	Macrocell clock to cluster memory output clock in the same cluster
Internal Paramet	ers
t _{CLMCLAA}	Asynchronous cluster memory access time from input of cluster memory to output of cluster memory



Channel Memory Timing Parameter Descriptions Over the Operating Range

Parameter	Description
Dual Port Async	hronous Mode Parameters
t _{CHMAA}	Channel memory access time. Delay from address change to read data out
t _{CHMPWE}	Write enable pulse width
t _{CHMSA}	Address set-up to the beginning of write enable with both signals from the same I/O block
t _{CHMHA}	Address hold after the end of write enable with both signals from the same I/O block
t _{CHMSD}	Data set-up to the end of write enable
t _{CHMHD}	Data hold after the end of write enable
t _{CHMBA}	Channel memory asynchronous dual port address match (busy access time)
	ronous Mode Parameters
t _{CHMCYC1}	Clock cycle time for flow through read and write operations (from macrocell register through channel memory back to a macrocell register in the same cluster)
t _{CHMCYC2}	Clock cycle time for pipelined read and write operations (from channel memory input register through the memory to channel memory output register)
t _{CHMS}	Address, data, and WE set-up time of pin inputs, relative to a global clock
t _{CHMH}	Address, data, and WE hold time of pin inputs, relative to a global clock
t _{CHMDV1}	Global clock to data valid on output pins for flow through data
t _{CHMDV2}	Global clock to data valid on output pins for pipelined data.
t _{CHMBDV}	Channel memory synchronous dual-port address match (busy, clock to data valid)
t _{CHMMACS1}	Channel memory input clock to macrocell clock in the same cluster
t _{CHMMACS2}	Channel memory output clock to macrocell clock in the same cluster
t _{MACCHMS1}	Macrocell clock to channel memory input clock in the same cluster
t _{MACCHMS2}	Macrocell clock to channel memory output clock in the same cluster
Synchronous Fll	FO Data Parameters
t _{CHMCLK}	Read and write minimum clock cycle time
t _{CHMFS}	Data, read enable, and write enable set-up time relative to pin inputs
t _{CHMFH}	Data, read enable, and write enable hold time relative to pin inputs
t _{CHMFRDV}	Data access time to output pins from rising edge of read clock (read clock to data valid)
t _{CHMMACS}	Channel memory FIFO read clock to macrocell clock for read data
t _{MACCHMS}	Macrocell clock to channel memory FIFO write clock for write data
Synchronous Fll	FO Flag Parameters
t _{CHMFO}	Read or write clock to respective flag output at output pins
t _{CHMMACF}	Read or write clock to macrocell clock with FIFO flag
t _{CHMFRS}	Master Reset Pulse Width
t _{CHMFRSR}	Master Reset Recovery Time
t _{CHMFRSF}	Master Reset to Flag and Data Output Time
t _{CHMSKEW1}	Read/Write Clock Skew Time for Full Flag
t _{CHMSKEW2}	Read/Write Clock Skew Time for Empty Flag
t _{CHMSKEW3}	Read/Write Clock Skew Time for Boundary Flags
Internal Paramet	iers
t _{CHMCHAA}	Asynchronous channel memory access time from input of channel memory to output of channel memory



250

125

83

Parameter Min. Max. Unit **Combinatorial Mode Parameters** t_{PD} 6.5 7.0 7.5 8.5 8.5 9.0 10 15 ns 4.0 4.5 5.0 5.6 6.5 7.5 9.0 10 t_{EA} ns 4.0 4.5 5.0 5.3 6.5 7.5 9.0 10 ns t_{ER} 6.0 6.0 6.0 6.0 6.0 7.0 8.0 10 ns t_{PRR} 9.0 9.5 10 10.5 11 12 13 15 ns t_{PRO} 3.0 3.3 3.6 4.0 4.5 5.0 6.0 7.0 t_{PRW} ns Synchronous Clocking Parameters 2.5 2.7 3.0 3.5 3.5 4.0 5.0 6.0 ns t_{MCS} 0.0 0.0 0.0 0.0 0.0 0.0 0.0 0.0 ns t_{MCH} 5.0 5.5 6.0 7.0 7.5 8.5 10 12 ns t_{MCCO} 0.8 0.9 1.0 1.2 1.4 1.7 2.0 2.5 ns t_{IOS} 1.4 0.8 0.9 1.0 1.2 1.7 2.0 2.5 t_{IOH} ns 3.2 3.6 4.0 4.5 5.0 6.0 7.0 8.0 t_{IOCO} ns 3.0 3.2 3.5 3.6 3.7 3.9 6.4 9.6 ns t_{SCS} 4.2 4.5 3.9 5.5 5.7 6.2 8.0 12 ns t_{SCS2} 4.0 4.5 5.0 5.5 6.0 6.5 8.0 12 ns t_{ICS} 4.0 4.5 5.0 5.5 6.0 6.5 8.0 12 tocs ns 3.5 3.5 3.5 3.8 4.0 4.4 6.0 7.0 ns t_{CHZ} 2.0 2.0 2.0 2.0 2.0 2.0 2.0 2.0 ns t_{CLZ} 333 313 286 278 270 256 156 104 MHz f_{MAX} 256 238 222 181 167 154 125 83 MHz f_{MAX2} **Product Term Clocking Parameters** 2.5 2.7 3.0 3.3 3.5 4.0 5.0 6.0 ns **t**_{MCSPT} 0.8 0.9 1.0 1.4 1.4 1.7 2.0 2.5 t_{MCHPT} ns 7.0 7.5 8.0 8.8 9.0 10.0 11.0 15.0 ns t_{MCCOPT} 7.2 5.5 6.0 6.5 7.5 9.0 10.0 15.0 ns t_{SCS2PT} **Channel Interconnect Parameters** 0.8 0.9 1.0 1.2 1.2 1.4 1.7 2.0 t_{CHSW} ns 1.6 1.8 2.0 2.3 2.4 2.6 2.8 3.0 ns t_{CL2CL} **Miscellaneous Parameters** 2.5 2.8 3.0 3.3 3.5 3.8 4.0 5.0 ns t_{CPLD} 0.2 0.22 0.25 0.28 0.30 0.32 0.35 0.38 ns t_{MCCD} **PLL Parameters** 0.45 0.48 0.50 0.50 0.55 0.58 0.60 0.65 ns t_{MCCJ} ± 320 ±330 ± 350 ±350 ±390 ± 400 ± 420 ±460 t_{DWSA} ps

Switching Characteristics - Parameter Values Over the Operating Range

200

181

167

154

222

t_{DWOSA}

t_{LOCK}

±320

3.0

±330

3.0

±350

3.0

±350

3.0

±390

3.0

±400

3.0

±420

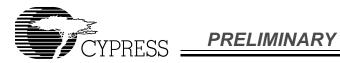
3.0

±460

3.0

ps

ms



-																
2	50	2	22	2	00	1	81	1	67	1	54	1	25	83		
Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Unit
6.2	266	6.2	266	6.2	266	6.2	266	6.2	266	6.2	266	6.2	200	6.2	200	MHz
25	133	25	133	25	133	25	133	25	133	25	133	25	100	25	100	MHz
neters		•	•	•		•	•	•	•	•	•	•	•	•	•	•
25		25		25		25		25		25		25		25		ns
25		25		25		25		25		25		25		25		ns
50		50		50		50		50		50		50		50		ns
10		10		10		10		10		10		10		10		ns
10		10		10		10		10		10		10		10		ns
	20		20		20		20		20		20		20		20	ns
	20		20		20		20		20		20		20		20	ns
	20		20		20		20		20		20		20		20	ns
	Min. 6.2 25 neters 25 25 50 10	6.2 266 25 133 neters 25 25 25 50 10 10 20 20 20	Max. Min. Max. Min. 6.2 266 6.2 25 133 25 neters 25 25 25 25 25 25 25 25 50 25 50 10 10 10 10 20 10 20 20 20	Min. Max. Min. Max. 6.2 266 6.2 266 25 133 25 133 neters 25 25 25 25 25 25 25 25 25 25 25 50 50 50 101 10 10 10 10 10 20 10 20 20 20 20 20	Man. Man. Max. Min. 6.2 266 6.2 266 6.2 25 133 25 133 25 neters 25 133 25 25 25 25 25 25 25 50 25 50 50 50 100 10 10 10 10 10 10 20 20 20 20	Max. Min. Max. Min. Max. 6.2 266 6.2 266 6.2 266 25 133 25 133 25 133 attempoint 255 133 25 133 25 133 attempoint 25 25 133 25 133 25 133 attempoint 25	Max. Min. Max. Min. Max. Min. 6.2 266 6.2 266 6.2 266 6.2 25 133 25 133 25 133 25 25 133 25 133 25 133 25 netters 25 266 25 25 25 25 25 25 25 25 25 25 25 25 25 25 25 50 25 50 50 50 50 50 10 10 10 10 10 10 10 20 10 20 20 10 20 20 20 20 20 20 20	Max. Min. Max. Min. Max. Min. Max. 6.2 266 6.2 266 6.2 266 6.2 266 25 133 25 133 25 133 25 133 25 133 25 133 25 133 25 133 neters 25 25 25 25 25 25 25 25 25 25 25 25 25 25 25 25 25 25 25 25 25 50 50 50 50 50 50 50 10 10 10 10 10 10 10 10 10 10 20 20 20 20 20 20 20 20 20 20 20 20 20 20 20	Max. Min. Max. Min. Max. Min. Max. Min. 6.2 266 6.2 266 6.2 266 6.2 266 6.2 25 133 25 133 25 133 25 133 25 neters 25 1 25 1 25 133 25 25 133 25 133 25 133 25 neters 25 10 10 10 10 10 10 10 <t< td=""><td>Min.Max.Min.Max.Min.Max.Min.Max.Min.Max.$6.2$266$6.2$266$6.2$266$6.2$266$6.2$266251332513325133251332513325133neters255050505050505050505010101010101010101010102020202020202020202020202020202020</td><td>Max.Max.Max.Max.Max.Max.Max.Max.Max.Max.Max.Max.Max.Max.$6.2$$266$$6.2$$256$$6.2$$256$$6.2$$256$$6.2$$256$$256$$256$$256$$256$$256$$256$$256$$256$$256$$256$$256$$256$$256$$256$$256$$256$$256$$506$$256$$506$$256$$506$$106$$106$$106$$106$$106$$106$$106$$106$$106$$106$$106$$106$$106$$106$$106$$106$$106$$206$$206$$206$$206$$206$</td><td>Max.Max.Max.Min.Max.Min.Max.Min.Max.Min.Max.Min.Max.6.22666.22666.22666.22666.22666.2266251332513325133251332513325133251332513325133251332513325133neters252625</td><td>Max.Ma</td><td>Max.Max.Max.Min.Max.Min.Max.Min.Max.Min.Max.Min.Max.Min.Max.Min.Max.Min.Max.$6.2$266$6.2$266$6.2$266$6.2$266$6.2$266$6.2$200$25$133251332513325133251332513325100neters$25$252525252525252625252625265025<</td><td>Max.M</td><td>Max. Min. Max. Min. <t< td=""></t<></td></t<>	Min.Max.Min.Max.Min.Max.Min.Max.Min.Max. 6.2 266 6.2 266 6.2 266 6.2 266 6.2 266251332513325133251332513325133neters255050505050505050505010101010101010101010102020202020202020202020202020202020	Max.Max.Max.Max.Max.Max.Max.Max.Max.Max.Max.Max.Max.Max. 6.2 266 6.2 256 6.2 256 6.2 256 6.2 256 256 256 256 256 256 256 256 256 256 256 256 256 256 256 256 256 256 506 256 506 256 506 106 106 106 106 106 106 106 106 106 106 106 106 106 106 106 106 106 206 206 206 206 206	Max.Max.Max.Min.Max.Min.Max.Min.Max.Min.Max.Min.Max.6.22666.22666.22666.22666.22666.2266251332513325133251332513325133251332513325133251332513325133neters252625	Max.Ma	Max.Max.Max.Min.Max.Min.Max.Min.Max.Min.Max.Min.Max.Min.Max.Min.Max.Min.Max. 6.2 266 6.2 266 6.2 266 6.2 266 6.2 266 6.2 200 25 133251332513325133251332513325100neters 25 252525252525252625252625265025<	Max.M	Max. Min. Max. Min. <t< td=""></t<>

Switching Characteristics - Parameter Values Over the Operating Range (continued)

Note:

13. Refer to page 11 and the application note titled "Delta39K PLL and Clock Tree" for details on the PLL operation & specification



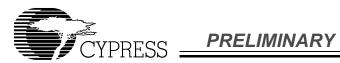
Input & Output Standard Timing Delay Adjustments

All the timing specifications in this data sheet are specified based on 3.3V PCI compliant inputs and outputs (fast slew rates).^[14] Apply following adjustments if the inputs and outputs are configured to operate at other standards.

Input/Output	Output De	lay Adjustmen	ts	Input Delay	Input Delay Adjustments						
Standard	t _{IOD}	t _{EA}	t _{ER}	t _{IOIN}	t _{CKIN}	t _{IOREGPIN}					
LVTTL – 2 mA	2.6	0	0	0	0	0					
LVTTL – 4 mA	2.0	0	0	0	0	0					
Input/OutputStandardtionLVTTL - 2 mA2.6		0	0	0	0	0					
LVTTL – 8 mA	1.2	0	0	0	0	0					
LVTTL – 12 mA	1.0	0	0	0	0	0					
LVTTL – 16 mA	0.5	0	0	0	0	0					
LVTTL – 24 mA	0.2	0	0	0	0	0					
LVCMOS	0.2	0	0	0	0	0					
LVCMOS3	0.3	0.05	0	0.1	0.1	0.2					
LVCMOS2	0.5	0.1	0	0.2	0.2	0.4					
LVCMOS18	2.1	0.7	0.1	0.5	0.4	0.3					
3.3V PCI	0	0	0	0	0	0					
GTL+	0.6 ^[15]	0.6 ^[15]	0.9 ^[15]	0.5	0.4	0.2					
SSTL3 I	-0.3	0.3	0.1	0.5	0.3	0.3					
SSTL3 II	-0.4	0.2	0	0.5	0.3	0.3					
SSTL2 I	-0.1	0.4	0	0.9	0.5	0.6					
SSTL2 II	-0.2	0.2	0	0.9	0.5	0.6					
HSTL I	0.6	0.9	0.5	0.5	0.5	0.3					
HSTL II	0.4	0.8	0.5	0.5	0.5	0.3					
HSTL III	0.6	0.5	0.1	0.5	0.5	0.3					
HSTL IV	0.7	0.6	0	0.5	0.5	0.3					

Notes:

For "slow slew rate" output delay adjustments, refer to Warp software's static timing analyzer results.
 These delays are based on falling edge output. The rising edge delay depends on the size of pull up resistor and termination voltage.



	2	50	2	22	2	00	1	81	1	67	1	54	1	25	8	33	
Parameter	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Unit
Asynchron	ous M	ode Pa	ramet	ers	•	•	•		•		•		•		•	•	
t _{CLMAA}		9		10		11		12		13		15		17		20	ns
t _{CLMPWE}	5		5.5		6		6.5		7		8		10		12		ns
t _{CLMSA}	1.6		1.8		2.0		2.2		2.5		2.8		3.2		4.0		ns
t _{CLMHA}	0.8		0.9		1.0		1.1		1.2		1.5		1.8		2.0		ns
t _{CLMSD}	5.0		5.5		6.0		6.5		7.0		8.0		10		12		ns
t _{CLMHD}	0.3		0.4		0.5		0.6		0.7		0.8		0.9		1.0		ns
Synchrono	us Mo	de Par	amete	rs													
t _{CLMCYC1}	9.0		9.5		10		10.5		11		13		15		20		ns
t _{CLMCYC2}	4.0		4.5		5.0		5.5		6.0		7.0		8.0		10.0		ns
t _{CLMS}	2.5		2.7		3.0		3.8		3.5		3.8		4.0		5.0		ns
t _{CLMH}	0.0		0.0		0.0		0.0		0.0		0.0		0.0		0.0		ns
t _{CLMDV1}		9.0		10		11		12		13		15		17		20	ns
t _{CLMDV2}		6.5		7.0		7.5		8.0		8.5		9.0		10		15	ns
t _{CLMMACS1}	7.0		7.5		8.0		8.5		9.0		10		12		15		ns
t _{CLMMACS2}	4.0		4.5		5.0		5.5		6.0		7.0		8.0		10		ns
t _{MACCLMS1}	3.2		3.6		4.0		4.4		4.8		5.5		6.6		8.0		ns
t _{MACCLMS2}	5.5		6.0		6.5		7.0		7.5		8.5		10		12		ns
Internal Par	amete	ers															
t _{CLMCLAA}	5		5.5		6		6.5		7		8		10		12		ns

Cluster Memory Timing Parameter Values Over the Operating Range



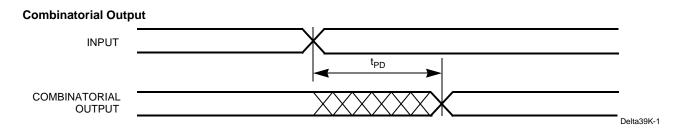
Channel Memory Timing Parameter Values

	250		222		200		181		167		154		125		83		
Parameter	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Unit
Dual-Port As	synch	ronous	s Mode	Paran	neters		1							1			
t _{CHMAA}		9		10		11		12		13		15		17		20	ns
t _{CHMPWE}	5.0		5.5		6.0		6.5		7.0		8.0		10		12		ns
t _{CHMSA}	1.6		1.8		2.0		2.2		2.5		2.8		3.2		4.0		ns
t _{CHMHA}	0.8		0.9		1.0		1.1		1.2		1.5		1.8		2.0		ns
t _{CHMSD}	5.0		5.5		6.0		6.5		7.0		8.0		10		12		ns
t _{CHMHD}	0.3		0.4		0.5		0.6		0.7		0.8		0.9		1.0		ns
t _{CHMBA}		8.0		8.5		9.0		10.0		11.0		12.0		14.0		16.0	ns
Dual-Port Sy	ynchro	nous	Mode	Param	eters												
t _{CHMCYC1}	9.0		9.5		10		10		11		13		15		20		ns
t _{CHMCYC2}	4.2		4.6		5.0		5.4		5.8		6.2		7.4		10.6		ns
t _{CHMS}	2.7		3.0		3.3		3.9		4.0		4.5		5.0		6.0		ns
t _{CHMH}	0.0		0.0		0.0		0.0		0.0		0.0		0.0		0.0		ns
t _{CHMDV1}		9.0		10		11		12		13		15		17		20	ns
t _{CHMDV2}		6.5		7.0		7.5		8.0		8.5		9.0		10		15	ns
t _{CHMBDV}		8.0		8.5		9.0		10.0		11.0		12.0		14.0		16.0	ns
t _{CHMMACS1}	8.0		8.5		9.0		10.0		11.0		12.0		14.0		16.0		ns
t _{CHMMACS2}	4.0		4.5		5.0		5.5		6.0		7.0		8.0		10		ns
t _{MACCHMS1}	4.2		4.6		5.0		5.4		5.8		6.5		7.6		9.0		ns
t _{MACCHMS2}	6.0		6.5		7.0		7.7		8.0		9.0		10.0		13.0		ns
Synchronou	IS FIFC	D Data	Param	neters													
t _{CHMCLK}	4.2		4.6		5.0		5.4		5.8		6.2		7.4		10.6		ns
t _{CHMFS}	3.5		3.7		4.0		4.3		4.5		5.0		6.0		7.0		ns
t _{CHMFH}	0.0		0.0		0.0		0.0		0.0		0.0		0.0		0.0		ns
t _{CHMFRDV}	6.0		6.5		7.0		7.5		8.0		9.0		10.0		13.0		
t _{CHMMACS}	4.2		4.6		5.0		5.4		5.8		6.2		7.4		10.6		ns
t _{MACCHMS}	4.2		4.6		5.0		5.4		5.8		6.2		7.4		10.6		ns
Synchronou	IS FIFO) Flag	Param	neters													
t _{CHMFO}	10.0		10.5		11		11.5		12		13		15		20		ns
t _{CHMMACF}	8.0		8.5		9		9.5		10		11		13		17		ns
t _{CHMFRS}	4.0		4.5		5.0		5.5		6.0		7.0		8.0		10		ns
t _{CHMFRSR}		3.2		3.6		4.0		4.4		4.8		5.5		6.6		8.0	ns
t _{CHMFRSF}		9.0		9.5		10.0		11.0		12.0		13.0		15.0		18.0	ns
t _{CHMSKEW1}		1.6		1.8		2.0		2.2		2.4		2.6		3.2		4.0	ns
t _{CHMSKEW2}		1.6		1.8		2.0		2.2		2.4		2.6		3.2		4.0	ns
t _{CHMSKEW3}		4.2		4.6		5.0		5.4		5.8		6.2		7.4		10.6	ns
Internal Para	amete	rs															
t _{CHMCHAA}	6.0		6.5		7.0		7.5		8.0		9.0		10.0		13.0		ns

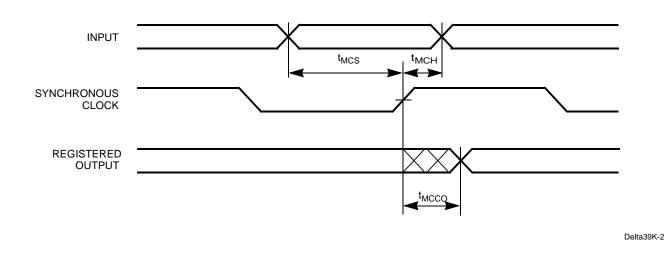


PRELIMINARY

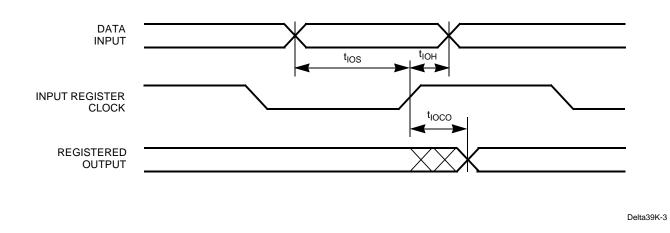
Switching Waveforms



Registered Output with Synchronous Clocking (Macrocell)



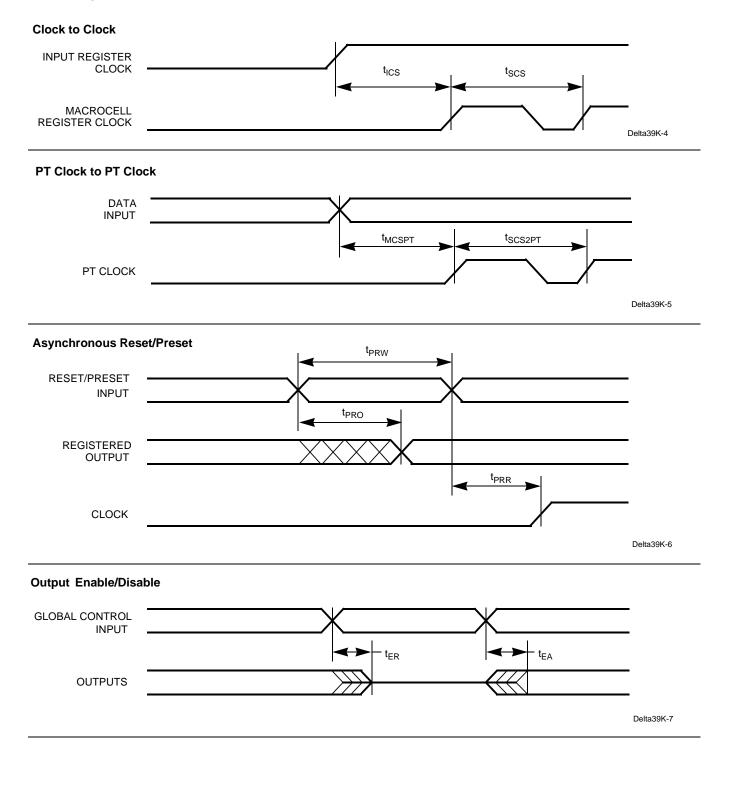
Registered Input in I/O Cell



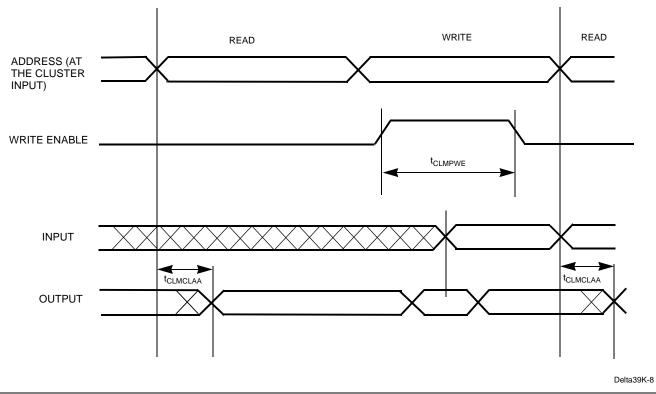


PRELIMINARY

Switching Waveforms (continued)

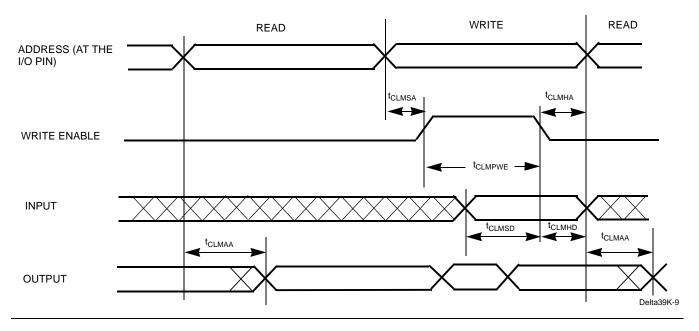




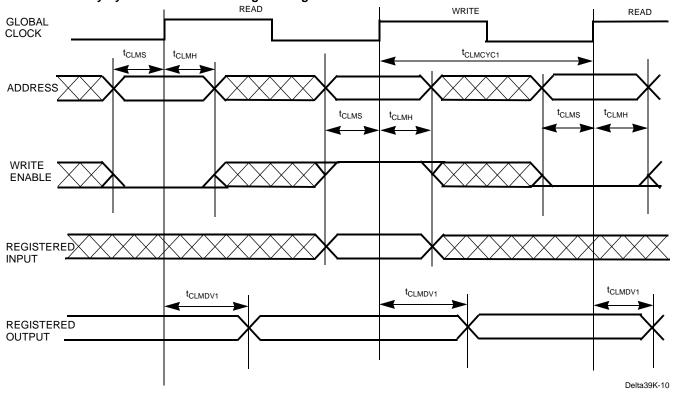


Cluster Memory Asynchronous Timing

Cluster Memory Asynchronous Timing 2

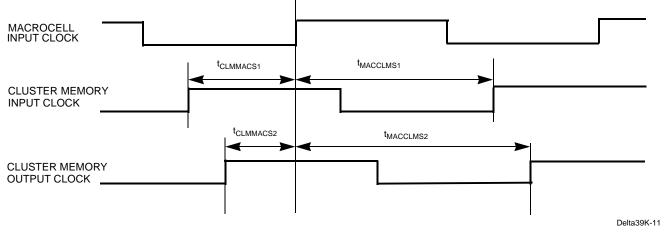


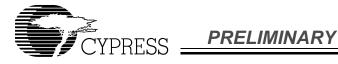




Cluster Memory Synchronous Flow Through Timing

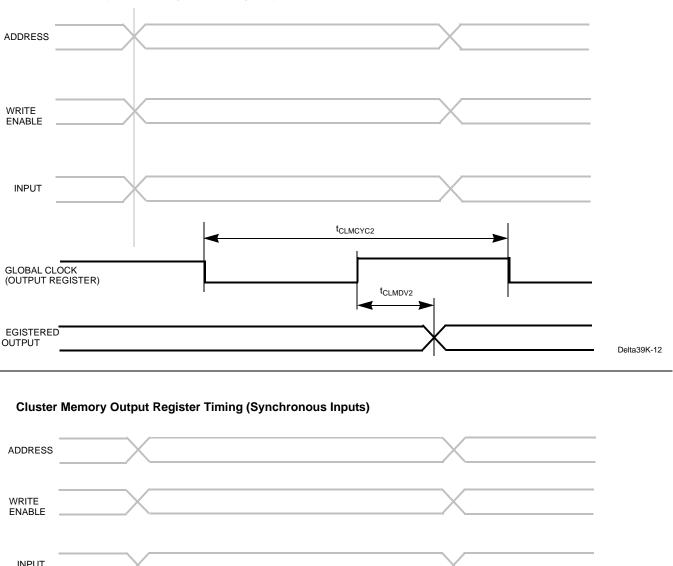




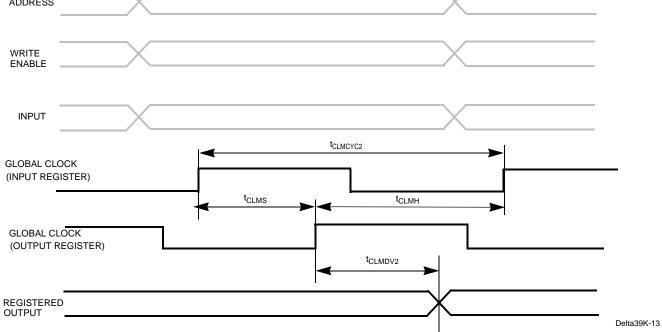


Delta39K[™] ISR[™] CPLD Family

Switching Waveforms (continued)

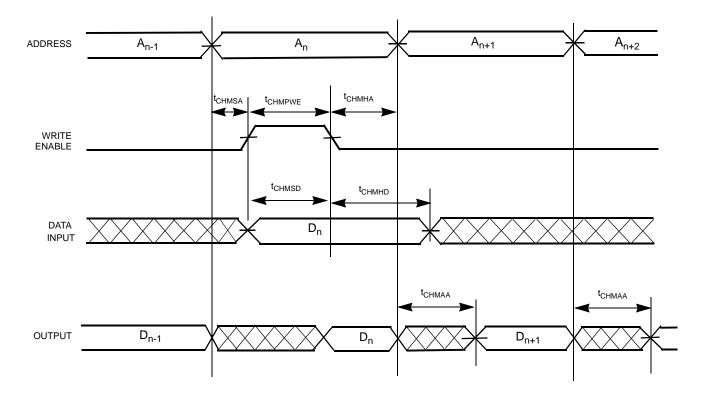


Cluster Memory Output Register Timing (Asynchronous Inputs)

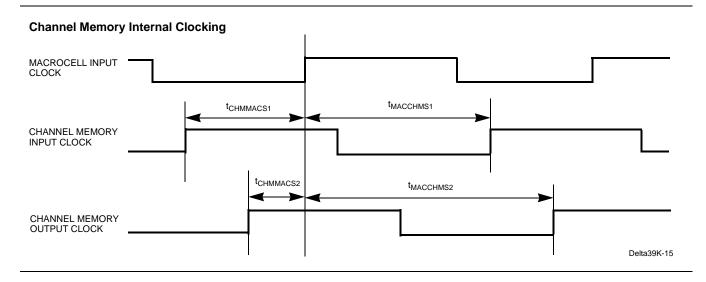




Channel Memory DP Asynchronous Timing

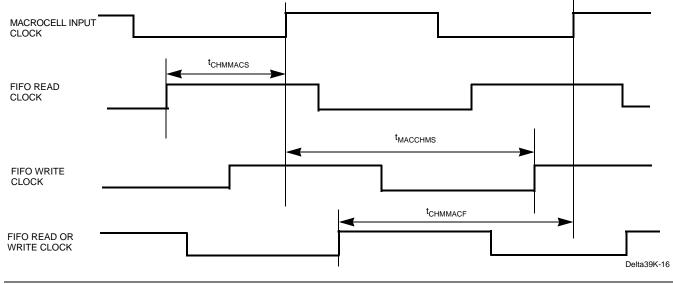


Delta39K-14

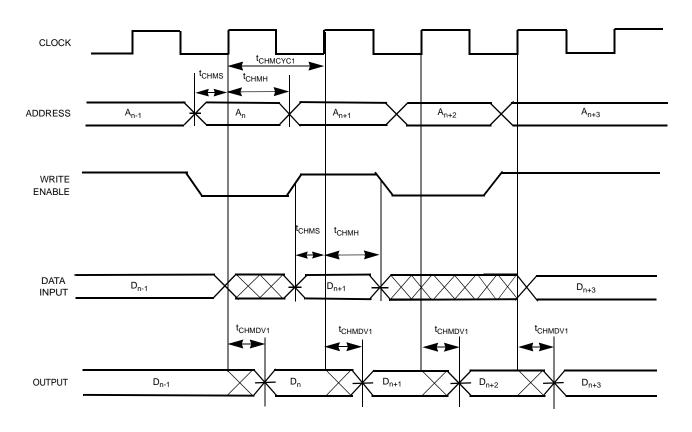




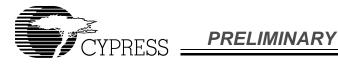
Channel Memory Internal Clocking 2



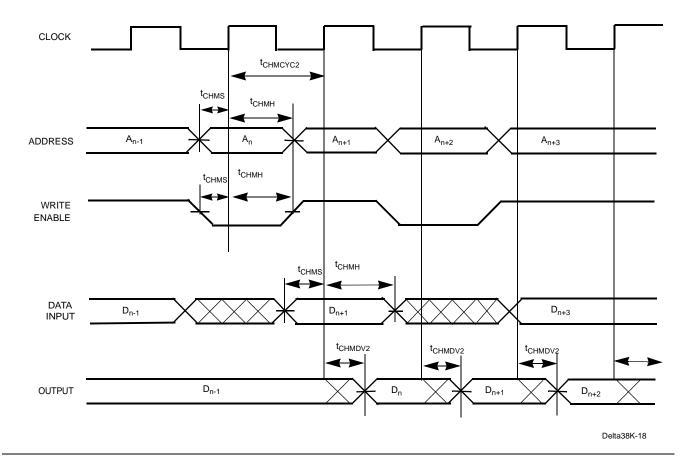
Channel Memory DP SRAM Flow Through R/W Timing



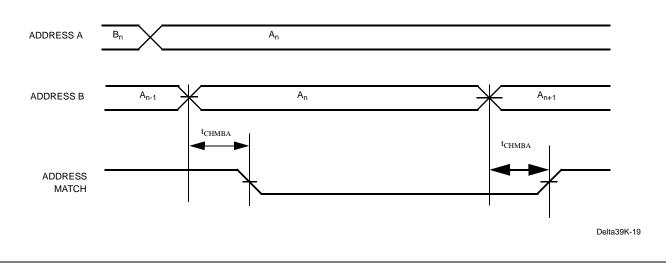
Delta39K-17



Channel Memory DP SRAM Pipeline R/W Timing





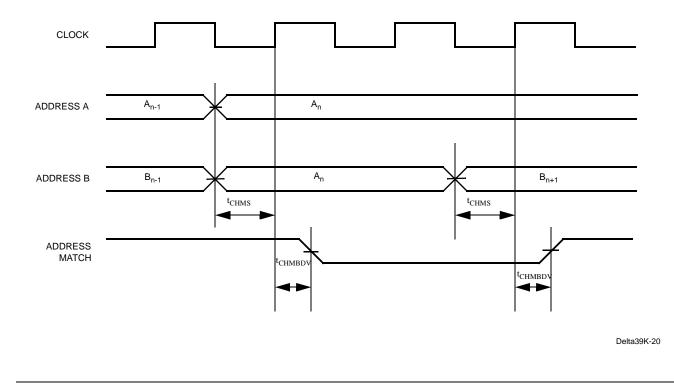




PRELIMINARY

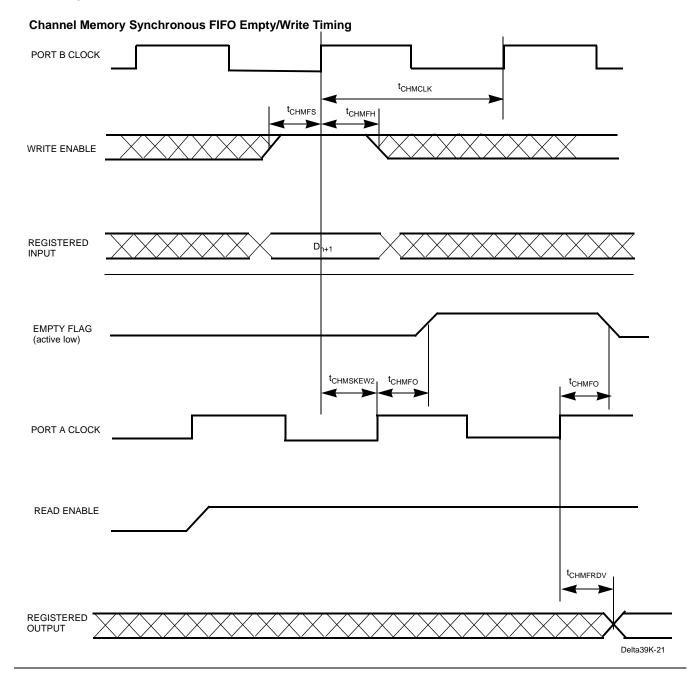
Switching Waveforms (continued)

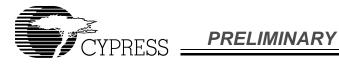
Dual-Port Synchronous Address Match Busy Signal





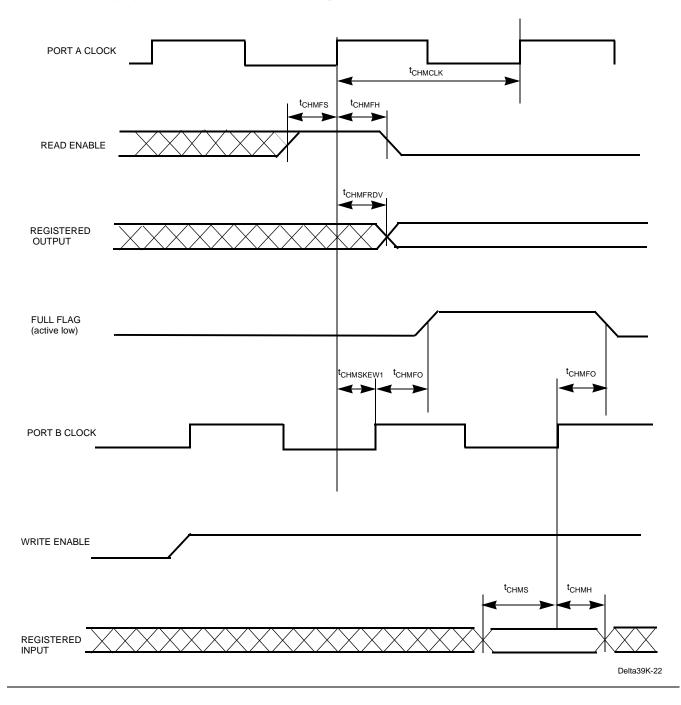
Switching Waveforms (continued)





Switching Waveforms (continued)

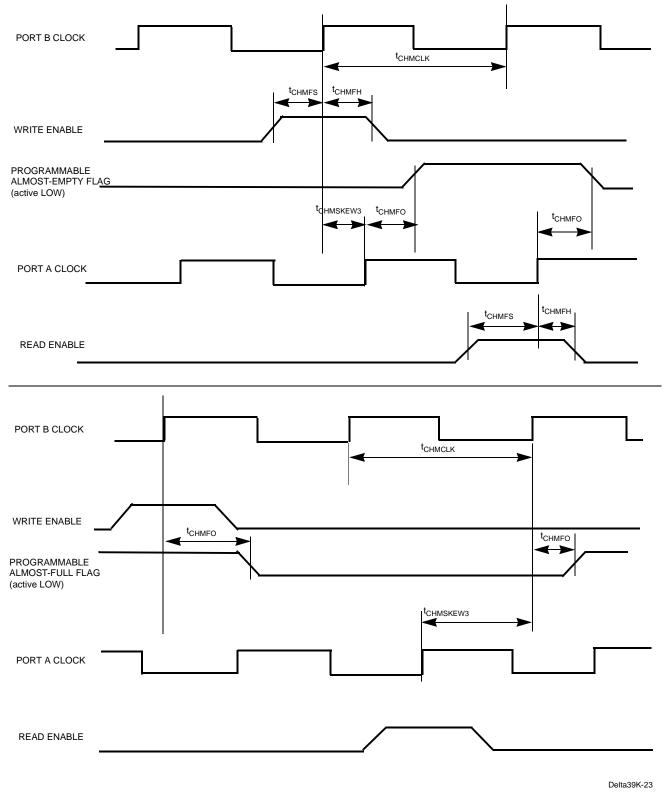
Channel Memory Synchronous FIFO Full/Read Timing





Switching Waveforms (continued)

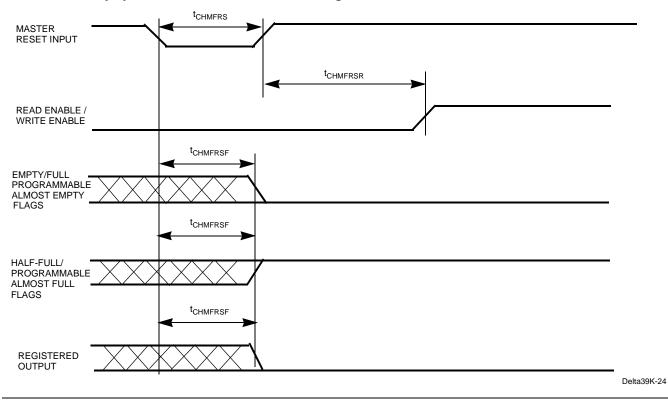
Channel Memory Synchronous FIFO Programmable Flag Timing



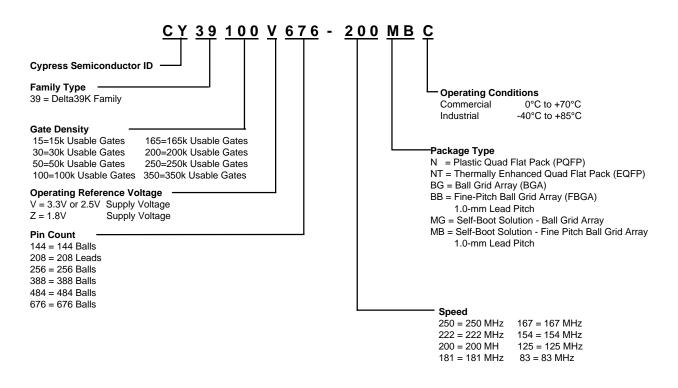


Switching Waveforms (continued)

Channel Memory Synchronous FIFO Master Reset Timing







Delta39K Pin Table

Please refer to document titled "Delta39K Pin Tables" for pinouts of all the packages of all Delta39K family members. You can access this document on the internet at: http://www.cypress.com/pld/datasheets.html.

Delta39K Part Numbers ^[16] (Ordering Information)	
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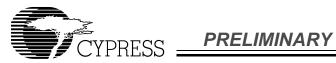
Device	Speed (MHz)	Ordering Code	Package Name	Package Type	Self-Boot Solution	Operating Range
39K15	250	CY39015V208-250NTC	NT208	208-Lead Enhanced Quad Flat Pack		Commercial
		CY39015Z208-250NC	N208	208-Lead Plastic Quad Flat Pack		
		CY39015V144-250BBC	BB144	144-Lead Fine Pitch Ball Grid Array		
		CY39015Z144-250BBC	BB144	144-Lead Fine Pitch Ball Grid Array		
		CY39015V256-250BBC	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39015Z256-250BBC	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39015V256-250MBC	MB256	256-Lead Fine Pitch Ball Grid Array		
		CY39015Z256-250MBC	MB256	256-Lead Fine Pitch Ball Grid Array		
	125	CY39015V208-125NTC	NT208	208-Lead Enhanced Quad Flat Pack		
		CY39015Z208-125NC	N208	208-Lead Plastic Quad Flat Pack		
		CY39015V144-125BBC	BB144	144-Lead Fine Pitch Ball Grid Array		
		CY39015Z144-125BBC	BB144	144-Lead Fine Pitch Ball Grid Array		
		CY39015V256-125BBC	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39015Z256-125BBC	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39015V256-125MBC	MB256	256-Lead Fine Pitch Ball Grid Array		1
		CY39015Z256-125MBC	MB256	256-Lead Fine Pitch Ball Grid Array	\checkmark	



Device	Speed (MHz)	Ordering Code	Package Name	Package Type	Self-Boot Solution	Operating Range
39K15	125	CY39015V208-125NTI	NT208	208-Lead Enhanced Quad Flat Pack		Industrial
		CY39015Z208-125NI	N208	208-Lead Plastic Quad Flat Pack		
		CY39015V144-125BBI	BB144	144-Lead Fine Pitch Ball Grid Array		
		CY39015Z144-125BBI	BB144	144-Lead Fine Pitch Ball Grid Array		-
		CY39015V256-125BBI	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39015Z256-125BBI	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39015V256-125MBI	MB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39015Z256-125MBI	MB256	256-Lead Fine Pitch Ball Grid Array		
	83	CY39015V208-83NTC	NT208	208-Lead Enhanced Quad Flat Pack		Commercial
		CY39015Z208-83NC	N208	208-Lead Plastic Quad Flat Pack		
		CY39015V144-83BBC	BB144	144-Lead Fine Pitch Ball Grid Array		
		CY39015Z144-83BBC	BB144	144-Lead Fine Pitch Ball Grid Array		
		CY39015V256-83BBC	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39015Z256-83BBC	BB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39015V256-83MBC	MB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39015Z256-83MBC	MB256	256-Lead Fine Pitch Ball Grid Array		
		CY39015V208-83NTI	NT208	208-Lead Plastic Quad Flat Pack		Industrial
		CY39015Z208-83NI	N208	208-Lead Enhanced Quad Flat Pack		-
		CY39015V144-83BBI	BB144	144-Lead Fine Pitch Ball Grid Array		-
		CY39015Z144-83BBI	BB144	144-Lead Fine Pitch Ball Grid Array		-
		CY39015V256-83BBI	BB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39015Z256-83BBI	BB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39015V256-83MBI	MB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39015Z256-83MBI	MB256	256-Lead Fine Pitch Ball Grid Array		-
39K30	222	CY39030V208-222NTC	NT208	208-Lead Enhanced Quad Flat Pack		Commercial
		CY39030Z208-222NC	N208	208-Lead Plastic Quad Flat Pack		-
		CY39030V144-222BBC	BB144	144-Lead Fine Pitch Ball Grid Array		-
		CY39030Z144-222BBC	BB144	144-Lead Fine Pitch Ball Grid Array		-
		CY39030V256-222BBC	BB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39030Z256-222BBC	BB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39030V256-222MBC	MB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39030Z256-222MBC	MB256	256-Lead Fine Pitch Ball Grid Array		-
ŀ	125	CY39030V208-125NTC	NT208	208-Lead Enhanced Quad Flat Pack		-
		CY39030Z208-125NC	N208	208-Lead Plastic Quad Flat Pack		-
		CY39030V144-125BBC	BB144	144-Lead Fine Pitch Ball Grid Array		-
		CY39030Z144-125BBC	BB144	144-Lead Fine Pitch Ball Grid Array		-
		CY39030V256-125BBC	BB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39030Z256-125BBC	BB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39030V256-125MBC	MB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39030Z256-125MBC	MB256	256-Lead Fine Pitch Ball Grid Array		1



Device	Speed (MHz)	Ordering Code	Package Name	Package Type	Self-Boot Solution	Operating Range
39K30	125	CY39030V208-125NTI	NT208	208-Lead Enhanced Quad Flat Pack		Industrial
		CY39030Z208-125NI	N208	208-Lead Plastic Quad Flat Pack		
		CY39030V144-125BBI	BB144	144-Lead Fine Pitch Ball Grid Array		
		CY39030Z144-125BBI	BB144	144-Lead Fine Pitch Ball Grid Array		
		CY39030V256-125BBI	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39030Z256-125BBI	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39030V256-125MBI	MB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39030Z256-125MBI	MB256	256-Lead Fine Pitch Ball Grid Array		-
	83	CY39030V208-83NTC	NT208	208-Lead Enhanced Quad Flat Pack		Commercial
		CY39030Z208-83NC	N208	208-Lead Plastic Quad Flat Pack		
		CY39030V144-83BBC	BB144	144-Lead Fine Pitch Ball Grid Array		
		CY39030Z144-83BBC	BB144	144-Lead Fine Pitch Ball Grid Array		
		CY39030V256-83BBC	BB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39030Z256-83BBC	BB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39030V256-83MBC	MB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39030Z256-83MBC	MB256	256-Lead Fine Pitch Ball Grid Array		
		CY39030V208-83NTI	NT208	208-Lead Plastic Quad Flat Pack		Industrial
		CY39030Z208-83NI	N208	208-Lead Enhanced Quad Flat Pack		-
		CY39030V144-83BBI	BB144	144-Lead Fine Pitch Ball Grid Array		-
		CY39030Z144-83BBI	BB144	144-Lead Fine Pitch Ball Grid Array		-
		CY39030V256-83BBI	BB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39030Z256-83BBI	BB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39030V256-83MBI	MB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39030Z256-83MBI	MB256	256-Lead Fine Pitch Ball Grid Array		-
39K50	222	CY39050V208-222NTC	NT208	208-Lead Enhanced Quad Flat Pack		Commercial
		CY39050Z208-222NC	N208	208-Lead Plastic Quad Flat Pack		-
		CY39050V256-222BBC	BB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39050Z256-222BBC	BB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39050V388-222MGC	MG388	388-Lead Ball Grid Array		-
		CY39050Z388-222MGC	MG388	388-Lead Ball Grid Array		-
		CY39050V484-222MBC	MB484	484-Lead Fine Pitch Ball Grid Array		-
		CY39050Z484-222MBC	MB484	484-Lead Fine Pitch Ball Grid Array		-
	125	CY39050V208-125NTC	NT208	208-Lead Enhanced Quad Flat Pack		-
		CY39050Z208-125NC	N208	208-Lead Plastic Quad Flat Pack		-
		CY39050V256-125BBC	BB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39050Z256-125BBC	BB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39050V388-125MGC	MG388	388-Lead Pitch Ball Grid Array		-
		CY39050Z388-125MGC	MG388	388-Lead Pitch Ball Grid Array		-
		CY39050V484-125MBC	MB484	484-Lead Fine Pitch Ball Grid Array		-
		CY39050Z484-125MBC	MB484	484-Lead Fine Pitch Ball Grid Array		1



Device	Speed (MHz)	Ordering Code	Package Name	Package Type	Self-Boot Solution	Operating Range
39K50	125	CY39050V208-125NTI	NT208	208-Lead Enhanced Quad Flat Pack		Industrial
		CY39050Z208-125NI	N208	208-Lead Plastic Quad Flat Pack		
		CY39050V256-125BBI	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39050Z256-125BBI	BB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39050V388-125MBI	MG388	388-Lead Fine Pitch Ball Grid Array		-
		CY39050Z388-125MBI	MG388	388-Lead Fine Pitch Ball Grid Array		
		CY39050V484-125MBI	MB484	484-Lead Fine Pitch Ball Grid Array		-
		CY39050Z484-125MBI	MB484	484-Lead Fine Pitch Ball Grid Array		-
	83	CY39050V208-83NTC	NT208	208-Lead Enhanced Quad Flat Pack		Commercial
		CY39050Z208-83NC	N208	208-Lead Plastic Quad Flat Pack		
		CY39050V256-83BBC	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39050Z256-83BBC	BB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39050V388-83MGC	MG388	388-Lead Ball Grid Array		
		CY39050Z388-83MGC	MG388	388-Lead Ball Grid Array		-
		CY39050V484-83MBC	MB484	484-Lead Fine Pitch Ball Grid Array		-
		CY39050Z484-83MBC	MB484	484-Lead Fine Pitch Ball Grid Array		-
		CY39050V208-83NTI	NT208	208-Lead Plastic Quad Flat Pack		Industrial
		CY39050Z208-83NI	N208	208-Lead Enhanced Quad Flat Pack		-
		CY39050V256-83BBI	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39050Z256-83BBI	BB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39050V388-83MGI	MG388	388-Lead Ball Grid Array]
		CY39050Z388-83MGI	MG388	388-Lead Ball Grid Array]
		CY39050V484-83MBI	MB484	484-Lead Fine Pitch Ball Grid Array		
		CY39050Z484-83MBI	MB484	484-Lead Fine Pitch Ball Grid Array]



Device	Speed (MHz)	Ordering Code	Package Name	Package Type	Self-Boot Solution	Operating Range
39K100	200	CY39100V208-200NTC	NT208	208-Lead Enhanced Quad Flat Pack		Commercial
[17]		CY39100V256-200BBC	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39100V484-200BBC	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39100V388-200MGC	MG388	388-Lead Ball Grid Array	\checkmark	
		CY39100V676-200MBC	MB676	676-Lead Fine Pitch Ball Grid Array	\checkmark	
		CY39100V208A-200NTC	NT208	208-Lead Enhanced Quad Flat Pack		
		CY39100V256A-200BBC	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39100V484A-200BBC	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39100V388A-200MGC	MG388	388-Lead Ball Grid Array	\checkmark	
		CY39100V676A-200MBC	MB676	676-Lead Fine Pitch Ball Grid Array	\checkmark	
		CY39100V208B-200NTC	NT208	208-Lead Enhanced Quad Flat Pack		
		CY39100Z208B-200NC	N208	208-Lead Plastic Quad Flat Pack		
		CY39100V256B-200BBC	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39100Z256B-200BBC	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39100V484B-200BBC	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39100Z484B-200BBC	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39100V388B-200MGC	MG388	388-Lead Ball Grid Array	\checkmark	
		CY39100Z388B-200MGC	MG388	388-Lead Ball Grid Array		
		CY39100V676B-200MBC	MB676	676-Lead Fine Pitch Ball Grid Array		
		CY39100Z676B-200MBC	MB676	676-Lead Fine Pitch Ball Grid Array	\checkmark	



Device	Speed (MHz)	Ordering Code	Package Name	Package Type	Self-Boot Solution	Operating Range
39K100	125	CY39100V208-125NTC	NT208	208-Lead Enhanced Quad Flat Pack		Commercial
[17]		CY39100V256-125BBC	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39100V484-125BBC	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39100V388-125MGC	MG388	388-Lead Ball Grid Array		
		CY39100V676-125MBC	MB676	676-Lead Fine Pitch Ball Grid Array		
		CY39100V208A-125NTC	NT208	208-Lead Enhanced Quad Flat Pack		
		CY39100V256A-125BBC	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39100V484A-125BBC	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39100V388A-125MGC	MG388	388-Lead Ball Grid Array		
		CY39100V676A-125MBC	MB676	676-Lead Fine Pitch Ball Grid Array		
		CY39100V208B-125NTC	NT208	208-Lead Enhanced Quad Flat Pack		
		CY39100Z208B-125NC	N208	208-Lead Plastic Quad Flat Pack		
		CY39100V256B-125BBC	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39100Z256B-125BBC	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39100V484B-125BBC	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39100Z484B-125BBC	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39100V388B-125MGC	MG388	388-Lead Ball Grid Array		
		CY39100Z388B-125MGC	MG388	388-Lead Ball Grid Array		
		CY39100V676B-125MBC	MB676	676-Lead Fine Pitch Ball Grid Array		
		CY39100Z676B-125MBC	MB676	676-Lead Fine Pitch Ball Grid Array		
		CY39100V208B-125NTI	NT208	208-Lead Enhanced Quad Flat Pack		Industrial
		CY39100Z208B-125NI	N208	208-Lead Plastic Quad Flat Pack		
		CY39100V256B-125BBI	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39100Z256B-125BBI	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39100V484B-125BBI	BB484	484-Lead Fine Pitch Ball Grid Array		1
		CY39100Z484B-125BBI	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39100V388B-125MGI	MG388	388-Lead Ball Grid Array		1
		CY39100Z388B-125MGI	MG388	388-Lead Ball Grid Array		
		CY39100V676B-125MBI	MB676	676-Lead Fine Pitch Ball Grid Array		1
		CY39100Z676B-125MBI	MB676	676-Lead Fine Pitch Ball Grid Array		



Device	Speed (MHz)	Ordering Code	Package Name	Package Type	Self-Boot Solution	Operating Range
39K100 [17]	83	CY39100V208-83NTC	NT208	208-Lead Enhanced Quad Flat Pack		Commercial
[17]		CY39100V256-83BBC	BB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39100V484-83BBC	BB484	484-Lead Fine Pitch Ball Grid Array		-
		CY39100V388-83MGC	MG388	388-Lead Ball Grid Array		-
		CY39100V676-83MBC	MB676	676-Lead Fine Pitch Ball Grid Array		-
		CY39100V208A-83NTC	NT208	208-Lead Enhanced Quad Flat Pack		-
		CY39100V256A-83BBC	BB256	256-Lead Fine Pitch Ball Grid Array		-
		CY39100V484A-83BBC	BB484	484-Lead Fine Pitch Ball Grid Array		-
		CY39100V388A-83MGC	MG388	388-Lead Ball Grid Array		-
		CY39100V676A-83MBC	MB676	676-Lead Fine Pitch Ball Grid Array		
		CY39100V208B-83NTC	NT208	208-Lead Enhanced Quad Flat Pack		
		CY39100Z208B-83NC	N208	208-Lead Plastic Quad Flat Pack		
		CY39100V256B-83BBC	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39100Z256B-83BBC	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39100V484B-83BBC	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39100Z484B-83BBC	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39100V388B-83MGC	MG388	388-Lead Ball Grid Array		
		CY39100Z388B-83MGC	MG388	388-Lead Ball Grid Array		
		CY39100V676B-83MBC	MB676	676-Lead Fine Pitch Ball Grid Array		
		CY39100Z676B-83MBC	MB676	676-Lead Fine Pitch Ball Grid Array		
		CY39100V208B-83NTI	NT208	208-Lead Enhanced Quad Flat Pack		Industrial
		CY39100Z208B-83NI	N208	208-Lead Plastic Quad Flat Pack		
		CY39100V256B-83BBI	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39100Z256B-83BBI	BB256	256-Lead Fine Pitch Ball Grid Array		
		CY39100V484B-83BBI	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39100Z484B-83BBI	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39100V388B-83MGI	MG388	388-Lead Ball Grid Array		
		CY39100Z388B-83MGI	MG388	388-Lead Ball Grid Array		
		CY39100V676B-83MBI	MB676	676-Lead Fine Pitch Ball Grid Array		
		CY39100Z676B-83MBI	MB676	676-Lead Fine Pitch Ball Grid Array		



Device	··· · · · · · · · · · · · · · · · · ·		Package Name	Package Type	Self-Boot Solution	Operating Range
39K165	181	CY39165V208-181NTC	NT208	208-Lead Enhanced Quad Flat Pack		Commercial
		CY39165Z208-181NC	N208	208-Lead Plastic Quad Flat Pack		
		CY39165V484-181BBC	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39165Z484-181BBC	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39165V388-181MGC	MG388	388-Lead Ball Grid Array	\checkmark	
		CY39165Z388-181MGC	MG388	388-Lead Ball Grid Array	\checkmark	
		CY39165V676-181MBC	MB676	676-Lead Fine Pitch Ball Grid Array		
		CY39165Z676-181MBC	MB676	676-Lead Fine Pitch Ball Grid Array		
	125	CY39165V208-125NTC	NT208	208-Lead Enhanced Quad Flat Pack		Commercial
		CY39165Z208-125NC	N208	208-Lead Plastic Quad Flat Pack		
		CY39165V484-125BBC	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39165Z484-125BBC	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39165V388-125MGC	MG388	388-Lead Ball Grid Array		-
		CY39165Z388-125MGC	MG388	388-Lead Ball Grid Array		-
		CY39165V676-125MBC	MB676	676-Lead Fine Pitch Ball Grid Array		-
		CY39165Z676-125MBC	MB676	676-Lead Fine Pitch Ball Grid Array		
		CY39165V208-125NTI	NT208	208-Lead Enhanced Quad Flat Pack		Industrial
		CY39165Z208-125NI	N208	208-Lead Plastic Quad Flat Pack		
		CY39165V484-125BBI	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39165Z484-125BBI	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39165V388-125MGI	MG388	388-Lead Ball Grid Array		
		CY39165Z388-125MGI	MG388	388-Lead Ball Grid Array		-
		CY39165V676-125MBI	MB676	676-Lead Fine Pitch Ball Grid Array		
		CY39165Z676-125MBI	MB676	676-Lead Fine Pitch Ball Grid Array		
	83	CY39165V208-83NTC	NT208	208-Lead Enhanced Quad Flat Pack		Commercial
		CY39165Z208-83NC	N208	208-Lead Plastic Quad Flat Pack		
		CY39165V484-83BBC	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39165Z484-83BBC	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39165V388-83MGC	MG388	388-Lead Ball Grid Array		-
		CY39165Z388-83MGC	MG388	388-Lead Ball Grid Array		
		CY39165V676-83MBC	MB676	676-Lead Fine Pitch Ball Grid Array		
		CY39165Z676-83MBC	MB676	676-Lead Fine Pitch Ball Grid Array		-
		CY39165V208-83NTI	NT208	208-Lead Enhanced Quad Flat Pack		Industrial
		CY39165Z208-83NI	N208	208-Lead Plastic Quad Flat Pack		
		CY39165V484-83BBI	BB484	484-Lead Fine Pitch Ball Grid Array		1
		CY39165Z484-83BBI	BB484	484-Lead Fine Pitch Ball Grid Array		1
		CY39165V388-83MGI	MG388	388-Lead Ball Grid Array		1
		CY39165Z388-83MGI	MG388	388-Lead Ball Grid Array		1
		CY39165V676-83MBI	MB676	676-Lead Fine Pitch Ball Grid Array		1
		CY39165Z676-83MBI	MB676	676-Lead Fine Pitch Ball Grid Array		1



Device	Speed (MHz)	Ordering Code	Package Name	Package Type	Self-Boot Solution	Operating Range
39K200	167	CY39200V208-167NTC	NT208	208-Lead Enhanced Quad Flat Pack		Commercia
		CY39200Z208-167NC	N208	208-Lead Plastic Quad Flat Pack		
		CY39200V484-167BBC		484-Lead Fine Pitch Ball Grid Array		
		CY39200Z484-167BBC	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39200V388-167MGC	MG388	388-Lead Ball Grid Array	\checkmark	
		CY39200Z388-167MGC	MG388	388-Lead Ball Grid Array	\checkmark	
		CY39200V676-167MBC	MB676	676-Lead Fine Pitch Ball Grid Array	\checkmark	
		CY39200Z676-167MBC	MB676	676-Lead Fine Pitch Ball Grid Array		
	125	CY39200V208-125NTC	NT208	208-Lead Enhanced Quad Flat Pack		Commercia
		CY39200Z208-125NC	N208	208-Lead Plastic Quad Flat Pack		
		CY39200V484-125BBC	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39200Z484-125BBC	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39200V388-125MGC	MG388	388-Lead Ball Grid Array	\checkmark	1
		CY39200Z388-125MGC	MG388	388-Lead Ball Grid Array	\checkmark	1
		CY39200V676-125MBC	MB676	676-Lead Fine Pitch Ball Grid Array		
		CY39200Z676-125MBC	MB676	676-Lead Fine Pitch Ball Grid Array		
		CY39200V208-125NTI	NT208	208-Lead Enhanced Quad Flat Pack		Industrial
		CY39200Z208-125NI	N208	208-Lead Plastic Quad Flat Pack		
		CY39200V484-125BBI	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39200Z484-125BBI	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39200V388-125MGI	MG388	388-Lead Ball Grid Array		
		CY39200V388-125MGI	MG388	388-Lead Ball Grid Array		-
		CY39200V676-125MBI	MB676	676-Lead Fine Pitch Ball Grid Array		
		CY39200Z676-125MBI	MB676	676-Lead Fine Pitch Ball Grid Array		-
	83	CY39200V208-83NTC	NT208	208-Lead Enhanced Quad Flat Pack		Commercia
		CY39200Z208-83NC	N208	208-Lead Plastic Quad Flat Pack		
		CY39200V484-83BBC	BB484	484-Lead Fine Pitch Ball Grid Array		-
		CY39200Z484-83BBC	BB484	484-Lead Fine Pitch Ball Grid Array		
		CY39200V388-83MGC	MG388	388-Lead Ball Grid Array		-
		CY39200Z388-83MGC	MG388	388-Lead Ball Grid Array		-
		CY39200V676-83MBC	MB676	676-Lead Fine Pitch Ball Grid Array		
		CY39200Z676-83MBC	MB676	676-Lead Fine Pitch Ball Grid Array		
		CY39200V208-83NTI	NT208	208-Lead Enhanced Quad Flat Pack		Industrial
		CY39200Z208-83NI	N208	208-Lead Plastic Quad Flat Pack		
		CY39200V484-83BBI	BB484	484-Lead Fine Pitch Ball Grid Array		1
		CY39200Z484-83BBI	BB484	484-Lead Fine Pitch Ball Grid Array		1
		CY39200V388-83MGI	MG388	388-Lead Ball Grid Array		1
		CY39200Z388-83MGI	MG388	388-Lead Ball Grid Array		1
		CY39200V676-83MBI	MB676	676-Lead Fine Pitch Ball Grid Array		1
		CY39200Z676-83MBI	MB676	676-Lead Fine Pitch Ball Grid Array		1

For the availability of Delta39KZ devices (1.8V), please contact your local sales office
 Refer to the section titled "Delta39K100 Revisions/Errata" on page 50



Delta39K100 Revisions/Errata

Three revisions of Delta39K100, in 3.3V version, are currently offered which are marked as CY39100Vxxx, CY39100VxxxA and CY39100VxxxB. CY39100VxxxB devices operate exactly as specified in this datasheet. Following paragraphs explain the operation of the CY39100Vxxx and CY39100VxxxA parts as different from this datasheet:

CY39100Vxxx

- 1. The internal regulator takes several seconds to power down. Hence, cycling the power supply (within 8 seconds) may cause a high standby current (200 mA to 1A) until the part is configured.
- The part always configures on power-up and will reconfigure on HIGH to LOW edge of the *Reconfig* pin. Please refer to the application note titled "Configuring Delta39K/Quantum38K" at http://www.cypress.com for more details.
- 3. The Self Config instruction starts reconfiguring the CPLD upon execution of the Update-IR state of the JTAG TAP controller state machine. In CY39100VxxxB parts, Self Config instruction is executed upon execution of Test-Log-ic-Reset state of the TAP controller.

4. An ESD failure is very unlikely. CDM ESD passes 1000V. HBM ESD passes 3300V with all I/O bank's V_{CCIO} shorted together. If V_{CCIO}s in a bank are tested separately a percentage of parts will fail HBM ESD over 500V.

CY39100VxxxA

- The part always configures on power-up and will reconfigure on HIGH to LOW edge of the *Reconfig* pin. Please refer to the application note titled "Configuring Delta39K/Quantum38K" at http://www.cypress.com for more details.
- 2. The Self Config instruction starts reconfiguring the CPLD upon execution of the Update-IR state of the JTAG TAP controller state machine. In CY39100VxxxB parts, Self Config instruction is executed upon execution of Test-Log-ic-Reset state of the TAP controller.
- 3. An ESD failure is very unlikely. CDM ESD passes 1000V. HBM ESD passes 3300V with all I/O bank's V_{CCIO} shorted together. If V_{CCIO}s in a bank are tested separately a percentage of parts will fail HBM ESD over 500V.



CPLD Boot EEPROM^[18] **Part Numbers (Ordering Information)**

Device	Speed (MHz)	Ordering Code	Package Name	Package Type	Operating Range
1Mbit	15	CY3LV010-10JC	20J	20-Lead Plastic Leaded Chip Carrier	Commercial
	10	CY3LV010-10JI	20J	20-Lead Plastic Leaded Chip Carrier	Industrial
512Kbit	15	CY3LV512-10JC	20J	20-Lead Plastic Leaded Chip Carrier	Commercial
	10	CY3LV512-10JI	20J	20-Lead Plastic Leaded Chip Carrier	Industrial

Recommended CPLD Boot EEPROM for corresponding Delta39K CPLDs

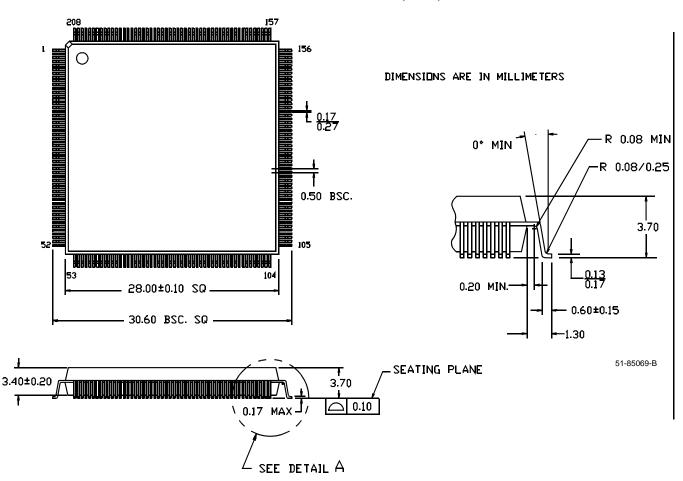
CPLD Device	Recommended boot EEPROM
39K15	CY3LV256
39K30	CY3LV512
39K50	CY3LV512
39K100	CY3LV010
39K165	CY3LV020
39K200	CY3LV020

Note:

18. See the data sheet titled "CPLD Boot EEPROM" for detailed architectural and timing information.



Package Diagrams



208-Lead Plastic Quad Flatpack (PQFP) N208 208-Lead Enhanced Quad Flat Pack (EQFP) NT208

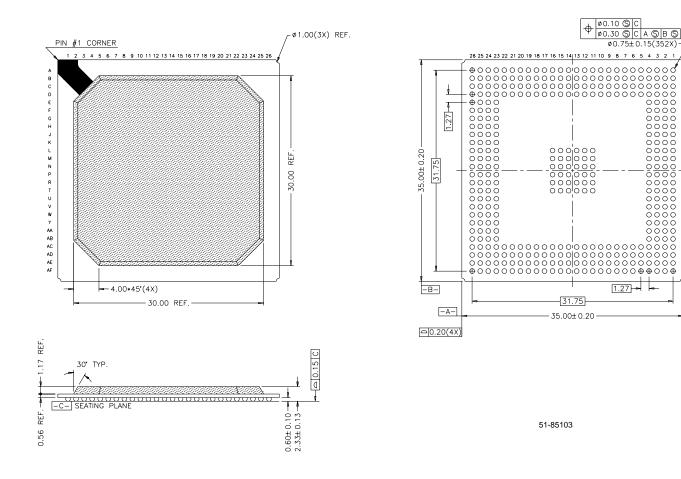


B C D E F

GHJKLMNPRTUVWYAA BACADAEAF

Package Diagrams (continued)

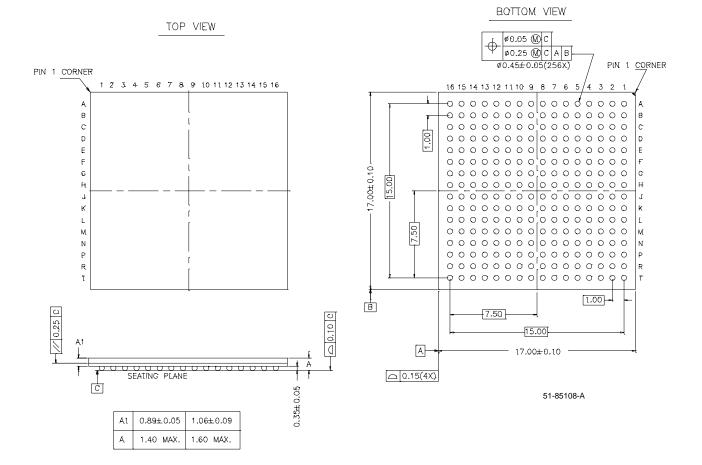
388-Lead Ball Grid Array MG388





Package Diagrams (continued)

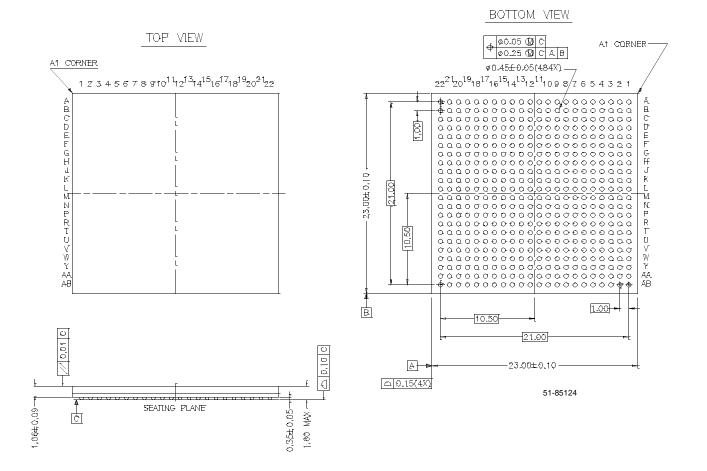
256-Ball Thin Ball Grid Array (17 x 17 x 1.6 mm) BB256/MB256





Package Diagrams (continued)

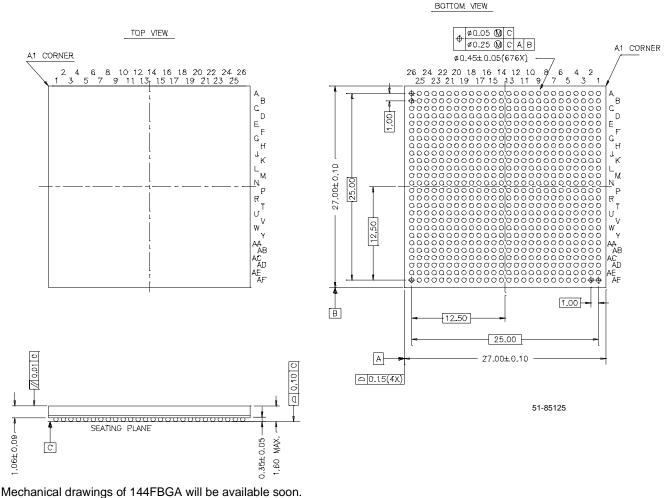
484-Ball Thin Ball Grid Array (23 x 23 x 1.6 mm) BB484/MB484





Package Diagrams (continued)

676-Ball FBGA (27 x 27 x 1.6 mm) BB676



For package sizes and ball pitch see page 2.

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Document Title: DELTA39K[™] ISR[™] CPLD FAMILY

Document number: 38-03039				
REV.	ECN NO.	Issue Date	Orig. of Change	Description of Change
**	106503	05/30/01	SZV	Change from Spec #: 38-00830 to 38-03039